

# **Micron Serial NOR Flash Memory**

1.8V, Multiple I/O, 4KB, 32KB, 64KB Sector Erase MT25QU512ABB

#### Features Options Marking Voltage SPI-compatible serial bus interface U - 1.7-2.0V Single and double transfer rate (STR/DTR) Density Clock frequency – 512Mb 512 - 166 MHz (MAX) for all protocols in STR Device stacking - 90 MHz (MAX) for all protocols in DTR Monolithic А Dual/quad I/O commands for increased through- Device generation В put up to 90 MB/s Die revision В Supported protocols in both STR and DTR • Pin configuration Extended I/O protocol HOLD# 1 Dual I/O protocol - RESET# and HOLD# 8 Quad I/O protocol Sector Size • Execute-in-place (XIP) Е – 64KB PROGRAM/ERASE SUSPEND operations Packages – JEDEC-standard, RoHS-· Volatile and nonvolatile configuration settings compliant Software reset - 24-ball T-PBGA 05/6mm × 8mm 12 Additional reset pin for selected part numbers (TBGA24) 3-byte and 4-byte address modes – enable memory Wafer level chip-scale package, 27 56 access beyond 128Mb balls, 9 active balls (XFWLBGA 0.5P) Dedicated 64-byte OTP area outside main memory 16-pin SOP2, 300 mil SF - Readable and user-lockable (SO16W, SO16-Wide, SOIC-16) Permanent lock with PROGRAM OTP command W-PDFN-88mm×6mm W9 Erase capability $(MLP8 8mm \times 6mm)$ Bulk erase Security features Sector erase 64KB uniform granularity - Standard security 0 - Subsector erase 4KB, 32KB granularity Special options · Security and write protection Standard S - Volatile and nonvolatile locking and software Automotive А write protection for each 64KB sector Operating temperature range Nonvolatile configuration locking – From –40°C to +85°C IT - Password protection From –40°C to +105°C AT - Hardware write protection: nonvolatile bits – From –40°C to +125°C UT (BP[3:0] and TB) define protected area size Program/erase protection during power-up CRC detects accidental changes to raw data • Electronic signature - JEDEC-standard 3-byte signature (BB20h) Extended device ID: two additional bytes identify device factory options

• JESD47H-compliant

nt25q-qlkt-u512-abb-0.pdf - Rev. F 1/18 EN

- Minimum 100,000 ERASE cycles per sector
- Data retention: 20 years (TYP)

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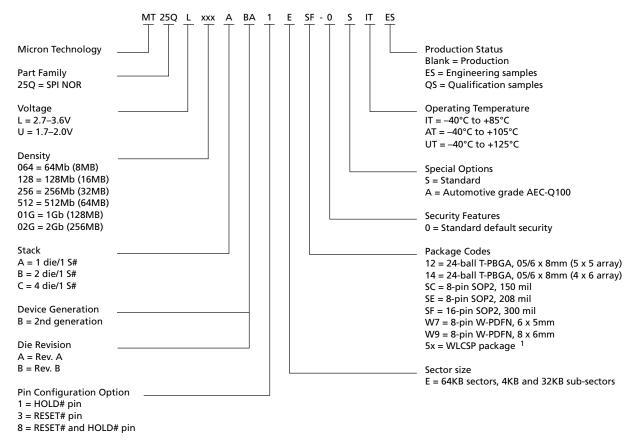
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#### **Part Number Ordering**

Micron Serial NOR Flash devices are available in different configurations and densities. Verify valid part numbers by using Micron's part catalog search at www.micron.com. To compare features and specifications by device type, visit www.micron.com/products. Contact the factory for devices not found.

#### **Figure 1: Part Number Ordering Information**



Note: 1. WLCSP package codes, package size, and availability are density-specific. Contact the factory for availability.



### Contents

Important Notes and Warnings	9
Device Description	10
Device Logic Diagram	11
Advanced Security Protection	11
Signal Assignments – Package Code: 12	12
Signal Assignments – Package Code: 56	13
Signal Assignments - Package Code: SF	. 14
Signal Assignments – Package Code: W9	. 14
Signal Descriptions	15
Package Dimensions - Package Code: 12	. 17
Package Dimensions - Package Code: 56	
Package Dimensions - Package Code: SF	19
Package Dimensions - Package Code: W9	20
Memory Map – 512Mb Density	
Status Register	
Block Protection Settings	
Flag Status Register	
Extended Address Register	
Internal Configuration Register	
Nonvolatile Configuration Register	
Volatile Configuration Register	
Supported Clock Frequencies	
Enhanced Volatile Configuration Register	
Security Registers	
Sector Protection Security Register	
Nonvolatile and Volatile Sector Lock Bits Security	
Volatile Lock Bit Security Register	37
Device ID Data	
Serial Flash Discovery Parameter Data	
Command Definitions	
Software RESET Operations	
RESET ENABLE and RESET MEMORY Commands	
READ ID Operations	47
READ ID and MULTIPLE I/O READ ID Commands	
READ SERIAL FLASH DISCOVERY PARAMETER Operation	
READ SERIAL FLASH DISCOVERY PARAMETER Command	
READ MEMORY Operations	
4-BYTE READ MEMORY Operations	
READ MEMORY Operations Timings	
WRITE ENABLE/DISABLE Operations	
READ REGISTER Operations	
WRITE REGISTER Operations	
CLEAR FLAG STATUS REGISTER Operation	62
PROGRAM Operations	
4-BYTE PROGRAM Operations	
PROGRAM Operations Timings	
ERASE Operations	
SUSPEND/RESUME Operations	
PROGRAM/ERASE SUSPEND Operations	
PROGRAM/ERASE RESUME Operations	
1	



#### 512Mb, 1.8V Multiple I/O Serial Flash Memory Features

ONE-TIME PROGRAMMABLE Operations       71         READ OTP ARRAY Command       71         PROGRAM OTP ARRAY Command       71         ADDRESS MODE Operations       73         ENTER and EXIT 4-BYTE ADDRESS MODE Command       73         DEEP POWER-DOWN Operations       74         ENTER DEEP POWER-DOWN Command       74         ENTER DEEP POWER-DOWN Command       74         RELEASE FROM DEEP POWER-DOWN Command       74         DEEP POWER-DOWN Timings       75         QUAD PROTOCOL Operations       77         ENTER or RESET QUAD INPUT/OUTPUT MODE Command       77         ENTER or RESET QUAD INPUT/OUTPUT MODE Command       77         CYCLLC REDUNDANCY CHECK Operations       78         State Table       80         Activate and Terminate XIP Using Volatile Configuration Register       81         Activate and Terminate XIP Using Nonvolatile Configuration Register       81         Confirmation Bit Settings Required to Activate or Terminate XIP       82         Power-Up and Power-Down       83         Power-Up and Power-Down Mequirements       83         Activate and Terminate XIP Using Nonvolatile Configuration Register       83         Active, Standby, and Deep Power-Down Modes       85         Power Up and Power-Down Mequirements		71
PROGRAM OTP ARRAY Command       71         ADDRESS MODE Operations       73         ENTER and EXIT 4-BVTE ADDRESS MODE Command       73         DEEP POWER-DOWN Operations       74         ENTER DEEP POWER-DOWN Command       74         ENTER DEEP POWER-DOWN Command       74         DEEP POWER-DOWN Timings       75         QUAD PROTOCOL Operations       77         ENTER OR RESE TQUAD INPUT//OUTPUT MODE Command       77         CYCLIC REDUNDANCY CHECK Operations       78         State Table       80         Activate and Terminate XIP Using Volatile Configuration Register       81         Activate and Terminate XIP Using Nonvolatile Configuration Register       81         Activate and Terminate XIP Using Volatile Configuration Register       81         Activate and Terminate XIP Using Nonvolatile Configuration Register       81         Activate and Terminate XIP Using Nonvolatile Configuration Register       82         Termination Bit Settings Required to Activate or Terminate XIP       82         Terminating XIP After a Controller and Memory Reset       83         Power-Up and Power-Down       83         Active, Standby, and Deep Power-Down Modes       85         Power Loss and Interface Rescue       86         Initial Delivery Status       87     <		
ADDRESS MODE Operations73ENTER and EXIT 4-BYTE ADDRESS MODE Command73DEP POWER-DOWN Operations74ENTER DEEP POWER-DOWN Command74ELEASE FROM DEEP POWER-DOWN Command74DEEP POWER-DOWN Timings75QUAD PROTOCOL Operations77ENTER or RESET QUAD INPUT/OUTPUT MODE Command77ENTER or RESET QUAD INPUT/OUTPUT MODE Command77CYCLIC REDUNDANCY CHECK Operations78State Table80XIP Mode81Activate and Terminate XIP Using Volatile Configuration Register81Activate and Terminate XIP Using Nonvolatile Configuration Register81Confirmation Bit Settings Required to Activate or Terminate XIP82Power-Up and Power-Down83Power-Up and Power-Down Requirements83Activate scovery86Power Loss Recovery86Power Loss Recovery86Interface Rescue86Initial Delivery Status87Absolute Ratings and Operating Conditions89AC Characteristics and Operating Conditions99AC Characteristics and Operating Conditions99Revision History90Revision History90Revision History90Revision History100Rev. C - 06/16100Rev. C - 06/16100Rev. C - 06/16100Rev. C - 06/16100Rev. C - 06/16100		
ENTER and EXIT <sup>4</sup> -BYTE ADDRESS MODE Command		
DEEP POWER-DOWN Operations74ENTER DEEP POWER-DOWN Command74RELEASE FROM DEEP POWER-DOWN Command74DEEP POWER-DOWN Timings75QUAD PROTOCOL Operations77ENTER or RESET QUAD INPUT/OUTPUT MODE Command77CYCLIC REDUNDANCY CHECK Operations78State Table80XIP Mode81Activate and Terminate XIP Using Volatile Configuration Register81Activate and Terminate XIP Using Nonvolatile Configuration Register81Confirmation Bit Settings Required to Activate or Terminate XIP82Terminating XIP After a Controller and Memory Reset83Power-Up and Power-Down Requirements83Active, standby, and Deep Power-Down Modes85Power Loss and Interface Rescue86Interface Rescue86Initial Delivery Status87Absolute Ratings and Operating Conditions90AC Characteristics and Operating Conditions92AC Reset Specifications92AC Reset Specifications99Revision History100Rev. F - 1/18100Rev. C - 06/17100Rev. C - 06/16100Rev. C - 06/16100		
ENTER DEEP POWER-DOWN Command74RELEASE FROM DEEP POWER-DOWN Timings75QUAD PROTOCOL Operations77ENTER or RESET QUAD INPUT/OUTPUT MODE Command77ENTER or RESET QUAD INPUT/OUTPUT MODE Command77CYCLIC REDUNDANCY CHECK Operations78State Table80XIP Mode81Activate and Terminate XIP Using Volatile Configuration Register81Activate and Terminate XIP Using Nonvolatile Configuration Register81Confirmation Bit Settings Required to Activate or Terminate XIP82Terminating XIP After a Controller and Memory Reset82Power-Up and Power-Down83Power-Up and Power-Down Modes85Power Loss and Interface Rescue86Recovery86Power Loss Recovery86Interface Rescue86Interface Rescue86Power		
RELEASE FROM DEEP POWER-DOWN Command74DEEP POWER-DOWN Timings75QUAD PROTOCOL Operations77ENTER or RESET QUAD INPUT/OUTPUT MODE Command77CYCLIC REDUNDANCY CHECK Operations78State Table80XIP Mode81Activate and Terminate XIP Using Volatile Configuration Register81Activate and Terminate XIP Using Nonvolatile Configuration Register81Confirmation Bit Settings Required to Activate or Terminate XIP82Terminating XIP After a Controller and Memory Reset82Power-Up and Power-Down83Power-Up and Power-Down Requirements83Active, Standby, and Deep Power-Down Modes85Power Loss and Interface Rescue86Interface Rescue89Revision History100Rev. F - 1/18100Rev		
DEEP POWER-DOWN Timings75QUAD PROTOCOL Operations77ENTER or RESET QUAD INPUT/OUTPUT MODE Command77CYCLIC REDUNDANCY CHECK Operations78State Table80XIP Mode81Activate and Terminate XIP Using Volatile Configuration Register81Activate and Terminate XIP Using Nonvolatile Configuration Register81Confirmation Bit Settings Required to Activate or Terminate XIP82Terminating XIP After a Controller and Memory Reset82Power-Up and Power-Down83Active, Standby, and Deep Power-Down Modes85Power Loss and Interface Rescue86Recovery86Interface Rescue86Interface Rescue86Power-Ipstand Operating Conditions90AC Characteristics and Operating Conditions92AC Reset Specifications95Program/Erase Specifications95Program/Erase Specifications99Revision History100Rev. F - 1/18100Rev. D - 06/16100Rev. C - 06/17100Rev. C - 06/16100Rev. C - 06/16	ENTER DEEP POWER-DOWN COMMINANT	74 74
QUAD PROTOCOL Operations77ENTER or RESET QUAD INPUT/OUTPUT MODE Command77CYCLLC REDUNDANCY CHECK Operations78State Table80XIP Mode81Activate and Terminate XIP Using Volatile Configuration Register81Activate and Terminate XIP Using Nonvolatile Configuration Register81Confirmation Bit Settings Required to Activate or Terminate XIP82Terminating XIP After a Controller and Memory Reset83Power-Up and Power-Down83Power-Up and Power-Down Requirements83Active, Standby, and Deep Power-Down Modes85Power Loss and Interface Rescue86Recovery86Initial Delivery Status87Absolute Ratings and Operating Conditions90AC Characteristics and Operating Conditions92AC Reset Specifications95Program/Erase Specifications95Program/Erase Specifications99Revision History100Rev. E - 06/17100Rev. C - 06/16100Rev. C - 06/16100		
ENTER or RESET QUAD INPUT/OUTPUT MODE Command77CYCLIC REDUNDANCY CHECK Operations78State Table80XIP Mode81Activate and Terminate XIP Using Volatile Configuration Register81Activate and Terminate XIP Using Nonvolatile Configuration Register81Confirmation Bit Settings Required to Activate or Terminate XIP82Terminating XIP After a Controller and Memory Reset82Power-Up and Power-Down83Power-Up and Power-Down Requirements83Active, Standby, and Deep Power-Down Modes85Power Loss and Interface Rescue86Recovery86Power Loss Recovery86Initial Delivery Status87Absolute Ratings and Operating Conditions87Absolute Ratings and Operating Conditions90AC Characteristics and Operating Conditions91AC Reset Specifications92AC Reset Specifications99Revision History100Rev. F - 1/18100Rev. C - 06/16100Rev. C - 06/16100Rev. C - 06/16100		
CYCLIC REDUNDANCY CHECK Operations78State Table80XIP Mode81Activate and Terminate XIP Using Volatile Configuration Register81Activate and Terminate XIP Using Nonvolatile Configuration Register81Confirmation Bit Settings Required to Activate or Terminate XIP82Terminating XIP After a Controller and Memory Reset82Power-Up and Power-Down Requirements83Power Up and Power-Down Modes85Power Loss and Interface Rescue86Recovery86Power Loss Recovery86Initial Delivery Status87Absolute Ratings and Operating Conditions88DC Characteristics and Operating Conditions90AC Characteristics and Operating Conditions91AC Reset Specifications95Program/Erase Specifications99Revision History100Rev E - 06/17100Rev. C - 06/16100Rev. C - 06/16100		
State Table80XIP Mode81Activate and Terminate XIP Using Volatile Configuration Register81Activate and Terminate XIP Using Nonvolatile Configuration Register81Confirmation Bit Settings Required to Activate or Terminate XIP82Terminating XIP After a Controller and Memory Reset82Power-Up and Power-Down83Power-Up and Power-Down Requirements83Active, Standby, and Deep Power-Down Modes85Power Loss and Interface Rescue86Interface Rescue86 <t< td=""><td></td><td></td></t<>		
XIP Mode81Activate and Terminate XIP Using Volatile Configuration Register81Activate and Terminate XIP Using Nonvolatile Configuration Register81Confirmation Bit Settings Required to Activate or Terminate XIP82Terminating XIP After a Controller and Memory Reset82Power-Up and Power-Down83Power-Up and Power-Down Requirements83Active, Standby, and Deep Power-Down Modes85Power Loss and Interface Rescue86Recovery86Power Loss Recovery86Interface Rescue86Interface Rescue87Absolute Ratings and Operating Conditions90AC Reset Specifications92AC Reset Specifications95Program/Erase Specifications99Revision History100Rev. F - 1/18100Rev. C - 06/16100Rev. C - 06/16100		
Activate and Terminate XIP Using Volatile Configuration Register81Activate and Terminate XIP Using Nonvolatile Configuration Register81Confirmation Bit Settings Required to Activate or Terminate XIP82Terminating XIP After a Controller and Memory Reset82Power-Up and Power-Down83Power-Up and Power-Down Requirements83Active, Standby, and Deep Power-Down Modes85Power Loss and Interface Rescue86Recovery86Power Loss Recovery86Interface Rescue86Interface Rescue87Absolute Ratings and Operating Conditions90AC Characteristics and Operating Conditions92AC Reset Specifications99Revision History100Rev. F - 06/17100Rev. C - 06/16100Rev. C - 06/16100Rev. C - 06/16100		
Activate and Terminate XIP Using Nonvolatile Configuration Register81Confirmation Bit Settings Required to Activate or Terminate XIP82Terminating XIP After a Controller and Memory Reset82Power-Up and Power-Down83Power-Up and Power-Down Requirements83Active, Standby, and Deep Power-Down Modes85Power Loss and Interface Rescue86Recovery86Interface Rescue86Interface Rescue87Absolute Ratings and Operating Conditions90AC Character		
Confirmation Bit Settings Required to Activate or Terminate XIP82Terminating XIP After a Controller and Memory Reset82Power-Up and Power-Down83Power-Up and Power-Down Requirements83Active, Standby, and Deep Power-Down Modes85Power Loss and Interface Rescue86Recovery86Power Loss Recovery86Interface Rescue86Interface Rescue86Interface Rescue86Interface Rescue86Interface Rescue86Interface Rescue86Interface Rescue86Interface Rescue86Interface Rescue86Interface Rescue87Absolute Ratings and Operating Conditions90AC Characteristics and Operating Conditions92AC Reset Specifications95Program/Erase Specifications99Revision History100Rev. F - 1/18100Rev. D - 06/16100Rev. C - 06/16100Rev. C - 06/16100	Activate and Terminate XIP Using volatile Configuration Register	81
Terminating XIP After a Controller and Memory Reset82Power-Up and Power-Down83Power-Up and Power-Down Requirements83Active, Standby, and Deep Power-Down Modes85Power Loss and Interface Rescue86Recovery86Power Loss Recovery86Interface Rescue86Interface Rescue87Absolute Ratings and Operating Conditions88DC Characteristics and Operating Conditions90AC Reset Specifications99Revision History100Rev. F - 1/18100Rev. C - 06/16100Rev. C - 06/16100	Activate and Terminate XIP Using Nonvolatile Configuration Register	81
Power-Up and Power-Down83Power-Up and Power-Down Requirements83Active, Standby, and Deep Power-Down Modes85Power Loss and Interface Rescue86Recovery86Interface Rescue86Interface Rescue86Interface Rescue86Interface Rescue86Interface Rescue86Delivery Status87Absolute Ratings and Operating Conditions88DC Characteristics and Operating Conditions90AC Characteristics and Operating Conditions92AC Reset Specifications95Program/Erase Specifications99Revision History100Rev. F - 1/18100Rev. E - 06/17100Rev. D - 06/16100Rev. C - 06/16100	Confirmation Bit Settings Required to Activate or Terminate XIP	82
Power-Up and Power-Down Requirements83Active, Standby, and Deep Power-Down Modes85Power Loss and Interface Rescue86Recovery86Interface Rescue86Interface Rescue86Initial Delivery Status87Absolute Ratings and Operating Conditions88DC Characteristics and Operating Conditions90AC Characteristics and Operating Conditions92AC Reset Specifications92AC Reset Specifications95Program/Erase Specifications99Revision History100Rev. F - 1/18100Rev. E - 06/17100Rev. D - 06/16100Rev. C - 06/16100	Ierminating XIP After a Controller and Memory Reset	82
Active, Standby, and Deep Power-Down Modes85Power Loss and Interface Rescue86Recovery86Power Loss Recovery86Interface Rescue86Initial Delivery Status87Absolute Ratings and Operating Conditions88DC Characteristics and Operating Conditions90AC Characteristics and Operating Conditions92AC Reset Specifications92AC Reset Specifications95Program/Erase Specifications99Revision History100Rev. F - 1/18100Rev. E - 06/17100Rev. D - 06/16100Rev. C - 06/16100		
Power Loss and Interface Rescue86Recovery86Power Loss Recovery86Interface Rescue86Initial Delivery Status87Absolute Ratings and Operating Conditions88DC Characteristics and Operating Conditions90AC Characteristics and Operating Conditions92AC Reset Specifications95Program/Erase Specifications99Revision History100Rev. F - 1/18100Rev. C - 06/16100Rev. C - 06/16100		
Recovery86Power Loss Recovery86Interface Rescue86Initial Delivery Status87Absolute Ratings and Operating Conditions88DC Characteristics and Operating Conditions90AC Characteristics and Operating Conditions92AC Reset Specifications95Program/Erase Specifications99Revision History100Rev. F - 1/18100Rev. E - 06/17100Rev. D - 06/16100Rev. C - 06/16100		
Power Loss Recovery86Interface Rescue86Initial Delivery Status87Absolute Ratings and Operating Conditions88DC Characteristics and Operating Conditions90AC Characteristics and Operating Conditions92AC Reset Specifications92Program/Erase Specifications95Program/Erase Specifications99Revision History100Rev. F - 1/18100Rev. E - 06/17100Rev. D - 06/16100Rev. C - 06/16100		
Interface Rescue86Initial Delivery Status87Absolute Ratings and Operating Conditions88DC Characteristics and Operating Conditions90AC Characteristics and Operating Conditions92AC Reset Specifications92Program/Erase Specifications95Program/Erase Specifications99Revision History100Rev. F - 1/18100Rev. E - 06/17100Rev. D - 06/16100Rev. C - 06/16100		
Initial Delivery Status87Absolute Ratings and Operating Conditions88DC Characteristics and Operating Conditions90AC Characteristics and Operating Conditions92AC Reset Specifications92Program/Erase Specifications95Program/Erase Specifications99Revision History100Rev. F - 1/18100Rev. E - 06/17100Rev. D - 06/16100Rev. C - 06/16100		
Absolute Ratings and Operating Conditions88DC Characteristics and Operating Conditions90AC Characteristics and Operating Conditions92AC Reset Specifications95Program/Erase Specifications99Revision History100Rev. F - 1/18100Rev. E - 06/17100Rev. D - 06/16100Rev. C - 06/16100		
DC Characteristics and Operating Conditions90AC Characteristics and Operating Conditions92AC Reset Specifications95Program/Erase Specifications99Revision History100Rev. F - 1/18100Rev. E - 06/17100Rev. D - 06/16100Rev. C - 06/16100		
AC Characteristics and Operating Conditions       92         AC Reset Specifications       95         Program/Erase Specifications       99         Revision History       100         Rev. F - 1/18       100         Rev. E - 06/17       100         Rev. D - 06/16       100         Rev. C - 06/16       100		
AC Reset Specifications       95         Program/Erase Specifications       99         Revision History       100         Rev. F - 1/18       100         Rev. E - 06/17       100         Rev. D - 06/16       100         Rev. C - 06/16       100		
Program/Érase Specifications       99         Revision History       100         Rev. F - 1/18       100         Rev. E - 06/17       100         Rev. D - 06/16       100         Rev. C - 06/16       100		
Revision History       100         Rev. F - 1/18       100         Rev. E - 06/17       100         Rev. D - 06/16       100         Rev. C - 06/16       100		
Rev. F - 1/18       100         Rev. E - 06/17       100         Rev. D - 06/16       100         Rev. C - 06/16       100		
Rev. E - 06/17       100         Rev. D - 06/16       100         Rev. C - 06/16       100		
Rev. D – 06/16		
Rev. C – 06/16		
	Rev. B – 03/16	
Rev. A – 06/15	Rev. A – 06/15	00
$D_{OV} D = 0.02/16$ 100	Rev. D – 06/16	100 100



## **List of Figures**

Figure 1:	Part Number Ordering Information	. 2
Figure 2:	Block Diagram	10
Figure 3:	Logic Diagram	11
Figure 4:	24-Ball T-BGA, 5 × 5 (Balls Down)	12
Figure 5:	27-Ball XFWLBGA (Top View)	13
Figure 6:	16-Pin, Plastic Small Outline – SO16 (Top View)	14
Figure 7:	8-Pin, W-PDFN (Top View)	14
Figure 8:	24-Ball T-PBGA (5 × 5 ball grid array) – 6mm × 8mm	17
Figure 9:	27-Ball XFWLBGA	18
Figure 10:	16-Pin SOP2 – 300 mil Body Width	19
Figure 11:	W-PDFN-8 (MLP8) – 8mm × 6mm	20
Figure 12:	Memory Array Segments	25
Figure 13:	Internal Configuration Register	26
Figure 14:	Sector and Password Protection	35
Figure 15:	RESET ENABLE and RESET MEMORY Command	46
Figure 16:	READ ID and MULTIPLE I/O READ ID Commands	47
Figure 17:	READ SERIAL FLASH DISCOVERY PARAMETER Command – 5Ah	48
Figure 18:	READ – 03h/13h <sup>3</sup>	51
Figure 19:	FAST READ – 0Bh/0Ch <sup>3</sup>	51
Figure 20:	DUAL OUTPUT FAST READ – 3Bh/3Ch <sup>3</sup>	52
Figure 21:	DUAL INPUT/OUTPUT FAST READ – BBh/BCh <sup>3</sup>	52
Figure 22:	QUAD OUTPUT FAST READ – 6Bh/6Ch <sup>3</sup>	53
Figure 23:	QUAD INPUT/OUTPUT FAST READ – EBh/ECh <sup>3</sup>	53
Figure 24:	$\hat{Q}$ UAD INPUT/OUTPUT WORD READ – E7h <sup>3</sup>	54
Figure 25:	DTR FAST READ – $0Dh/0Eh^3$	55
Figure 26:	DTR DUAL OUTPUT FAST READ – 3Dh <sup>3</sup>	55
Figure 27:	DTR DUAL INPUT/OUTPUT FAST READ – BDh <sup>3</sup>	56
Figure 28:	DTR QUAD OUTPUT FAST READ – 6Dh <sup>3</sup>	57
Figure 29:	DTR QUAD INPUT/OUTPUT FAST READ – EDh <sup>3</sup>	57
Figure 30:	WRITE ENABLE and WRITE DISABLE Timing	58
Figure 31:	READ REGISTER Timing	59
Figure 32:	WRITE REGISTER Timing	61
Figure 33:	CLEAR FLAG STATUS REGISTER Timing	62
Figure 34:	PAGE PROGRAM Command	64
Figure 35:	DUAL INPUT FAST PROGRAM Command	65
	EXTENDED DUAL INPUT FAST PROGRAM Command	
	QUAD INPUT FAST PROGRAM Command	
Figure 38:	EXTENDED QUAD INPUT FAST PROGRAM Command	66
Figure 39:	SUBSECTOR and SECTOR ERASE Timing	68
	BULK ERASE Timing	
Figure 41:	PROGRAM/ERASE SUSPEND and RESUME Timing	70
Figure 42:	READ OTP Command Timing	71
Figure 43:	PROGRAM OTP Command Timing	72
Figure 44:	ENTER DEEP POWER-DOWN Timing	75
Figure 45:	RELEASE FROM DEEP POWER-DOWN Timing	76
	XIP Mode Directly After Power-On	
	Power-Up Timing	
Figure 48:	AC Timing Input/Output Reference Levels	89
	Reset AC Timing During PROGRAM and ERASE Cycle	
Figure 50:	Reset Enable and Reset Memory Timing	96



#### 512Mb, 1.8V Multiple I/O Serial Flash Memory Features

Figure 51:	Serial Input Timing STR	96
	Serial Input Timing DTR	
	Write Protect Setup and Hold During WRITE STATUS REGISTER Operation (SRWD = 1)	
Figure 54:	Hold Timing	97
Figure 55:	Output Timing for STR	98
Figure 56:	Output Timing for DTR	98



## **List of Tables**

	criptions	
	ſap	
	ister	
	Area	
	s Register	
Table 6: Extended	Address Register	25
Table 7: Nonvolatil	e Configuration Register	27
Table 8: Volatile Co	nfiguration Register	29
Table 9: Sequence	of Bytes During Wrap	29
Table 10: Clock Fre	quencies – STR (in MHz) for IT and AT part	30
Table 11: Clock Fre	quencies – STR (in MHz) for UT part	30
Table 12: Clock Fre	quencies – DTR (in MHz) for IT and AT part	32
	quencies – DTR (in MHz) for UT part	
	d Volatile Configuration Register	
	otection Register	
	eeze Bit	
	ile and Volatile Lock Bits	
	ock Bit Register	
	) Data	
	Device ID Data, First Byte	
	d Set	
	NABLE and RESET MEMORY Operations	
	and MULTIPLE I/O READ ID Operations	
	EMORY Operations	
	EAD MEMORY Operations	
	NABLE/DISABLE Operations	
	GISTER Operations	
	EGISTER Operations	
	LAG STATUS REGISTER Operation	
	M Operations	
Table 31: 4-BYTE P	ROGRAM Operations	64
	perations	
	D/RESUME Operations	
	trol Byte (Byte 64)	
	nd EXIT 4-BYTE ADDRESS MODE Operations	
	WER-DOWN Operations	
	nd RESET QUAD PROTOCOL Operations	
	mand Sequence on Entire Device	
	mand Sequence on a Range	
	ns Allowed/Disallowed During Device States	
	irmation Bit	
	Running XIP in Different Protocols	
	p Timing and $V_{WI}$ Threshold	
	Ratings	
	g Conditions	
	tput Capacitance	
Table 17. AC Timin	g Input/Output Conditions	20
	ent Characteristics and Operating Conditions	
	ge Characteristics and Operating Conditions	
	uency supported	
Table 50. Max frequ	uency supported	32



#### 512Mb, 1.8V Multiple I/O Serial Flash Memory Features

Table 51:	AC Characteristics and Operating Conditions	92
	AC RESET Conditions	
Table 53:	Program/Erase Specifications	99



### **Important Notes and Warnings**

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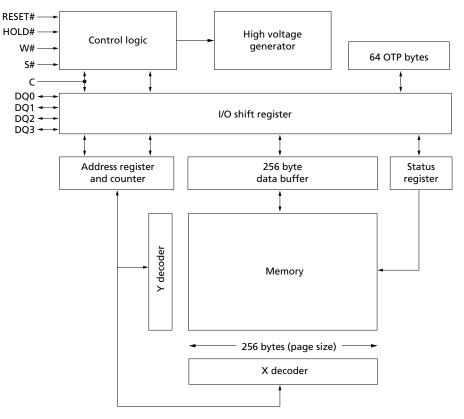
Limited Warranty. In no event shall Micron be liable for any indirect, incidental, punitive, special or consequential damages (including without limitation lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort, warranty, breach of contract or other legal theory, unless explicitly stated in a written agreement executed by Micron's duly authorized representative.



### **Device Description**

The MT25Q is a high-performance multiple input/output serial Flash memory device. It features a high-speed SPI-compatible bus interface, execute-in-place (XIP) functionality, advanced write protection mechanisms, and extended address access. Innovative, high-performance, dual and quad input/output commands enable double or quadruple the transfer bandwidth for READ and PROGRAM operations.

#### Figure 2: Block Diagram

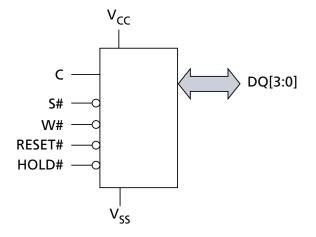


Note: 1. Each page of memory can be individually programmed, but the device is not page-erasable.



### **Device Logic Diagram**

#### Figure 3: Logic Diagram



- Notes: 1. Depending on the selected device (see Part Numbering Ordering Information), DQ3 = DQ3/RESET# or DQ3/HOLD#.
  - 2. A separate RESET pin is available on dedicated part numbers (see Part Numbering Ordering Information).

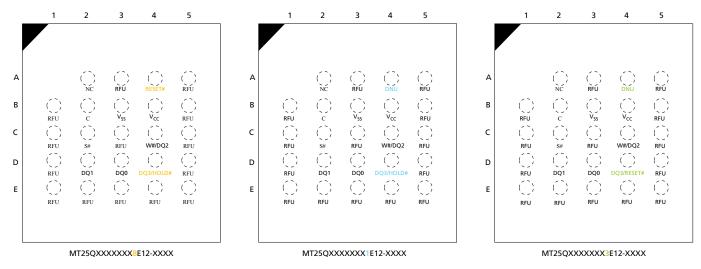
#### **Advanced Security Protection**

The device offers an advanced security protection scheme where each sector can be independently locked, by either volatile or nonvolatile locking features. The nonvolatile locking configuration can also be locked, as well password-protected. See Block Protection Settings and Sector and Password Protection for more details.



### Signal Assignments – Package Code: 12

#### Figure 4: 24-Ball T-BGA, 5 × 5 (Balls Down)

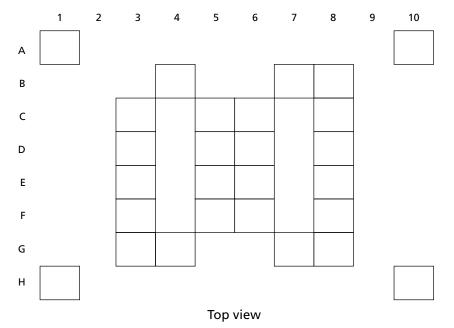


- Notes: 1. RESET# or HOLD# signals can share Ball D4 with DQ3, depending on the selected device (see Part Numbering Ordering Information). When using single and dual I/O commands on these parts, DQ3 must be driven high by the host, or an external pull-up resistor must be placed on the PCB, in order to avoid allowing the HOLD# or RESET# input to float.
  - 2. Ball A4 = RESET# or DNU, depending on the part number. This signal has an internal pull-up resistor and may be left unconnected if not used.



### Signal Assignments – Package Code: 56

#### Figure 5: 27-Ball XFWLBGA (Top View)

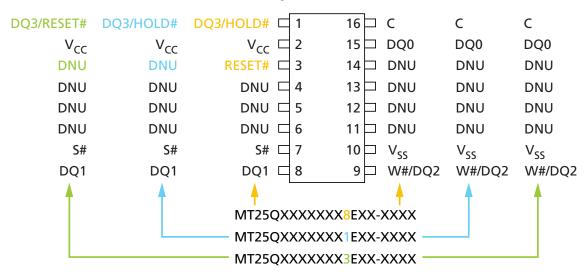


Note: 1. For detail information about this package option, contact the factory to request the data sheet addendum.



### Signal Assignments – Package Code: SF

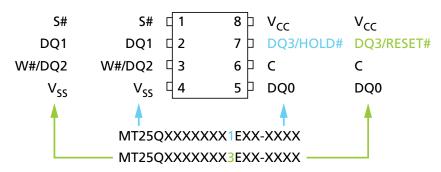
Figure 6: 16-Pin, Plastic Small Outline – SO16 (Top View)



- RESET# or HOLD# signals can share Pin 1 with DQ3, depending on the selected device (see Part Numbering Ordering Information). When using single and dual I/O commands on these parts, DQ3 must be driven high by the host, or an external pull-up resistor must be placed on the PCB, in order to avoid allowing the HOLD# or RESET# input to float.
  - 2. Pin 3 = RESET# or DNU, depending on the part number. This signal has an internal pullup resistor and may be left unconnected if not used.

### Signal Assignments – Package Code: W9

#### Figure 7: 8-Pin, W-PDFN (Top View)



- RESET# or HOLD# signals can share Pin 7 with DQ3, depending on the selected device (see Part Numbering Ordering Information). When using single and dual I/O commands on these parts, DQ3 must be driven high by the host, or an external pull-up resistor must be placed on the PCB, in order to avoid allowing the HOLD# or RESET# input to float.
  - 2. On the underside of the W-PDFN package, there is an exposed central pad that is pulled internally to  $V_{SS}$ . It can be left floating or can be connected to  $V_{SS}$ . It must not be connected to any other voltage or signal line on the PCB.
  - 3. MT25QXXXXX8EXX-XXXX not available on 8 pin package



### **Signal Descriptions**

The signal description table below is a comprehensive list of signals for the MT25Q family devices. All signals listed may not be supported on this device. See Signal Assignments for information specific to this device.

#### **Table 1: Signal Descriptions**

Symbol	Туре	Description
S#	Input	<b>Chip select:</b> When S# is driven HIGH, the device will enter standby mode, unless an internal PROGRAM, ERASE, or WRITE STATUS REGISTER cycle is in progress. All other input pins are ignored and the output pins are tri-stated. On parts with the pin configuration offering a dedicated RESET# pin, however, the RESET# input pin remains active even when S# is HIGH.
		Driving S# LOW enables the device, placing it in the active mode.
		After power-up, a falling edge on S# is required prior to the start of any command.
С	Input	<b>Clock:</b> Provides the timing of the serial interface. Command inputs are latched on the rising edge of the clock. In STR commands or protocol, address and data inputs are latched on the rising edge of the clock, while data is output on the falling edge of the clock. In DTR commands or protocol, address and data inputs are latched on both edges of the clock, and data is output on both edges of the clock.
RESET#	Input	<b>RESET#:</b> When RESET# is driven LOW, the device is reset and the outputs are tri-stated. If RE-SET# is driven LOW while an internal WRITE, PROGRAM, or ERASE operation is in progress, data may be lost. The RESET# functionality can be disabled using bit 4 of the nonvolatile configuration register or bit 4 of the enhanced volatile configuration register.
		For pin configurations that share the DQ3 pin with RESET#, the RESET# functionality is disabled in QIO-SPI mode.
HOLD#	Input	<b>HOLD:</b> Pauses serial communications with the device without deselecting or resetting the device. Outputs are tri-stated and inputs are ignored. The HOLD# functionality can be disabled using bit 4 of the nonvolatile configuration register or bit 4 of the enhanced volatile configuration register.
		For pin configurations that share the DQ3 pin with HOLD#, the HOLD# functionality is disabled in QIO-SPI mode or when DTR operation is enabled.
W#	Input	<b>Write protect:</b> Freezes the status register in conjunction with the enable/disable bit of the status register. When the enable/disable bit of the status register is set to 1 and the W# signal is driven LOW, the status register nonvolatile bits become read-only and the WRITE STATUS REG-ISTER operation will not execute. During the extended-SPI protocol with QOFR and QIOFR instructions, and with QIO-SPI protocol, this pin function is an input/output as DQ2 functionality. This signal does not have internal pull-ups, it cannot be left floating and must be driven, even if none of W#/DQ2 function is used.
DQ[3:0]	I/O	Serial I/O: The bidirectional DQ signals transfer address, data, and command information.
		When using legacy (x1) SPI commands in extended I/O protocol (XIO-SPI), DQ0 is an input and DQ1 is an output. DQ[3:2] are not used.
		When using dual commands in XIO-SPI or when using DIO-SPI, DQ[1:0] are I/O. DQ[3:2] are not used.
		When using quad commands in XIO-SPI or when using QIO-SPI, DQ[3:0] are I/O.
V <sub>CC</sub>	Supply	Core and I/O power supply.

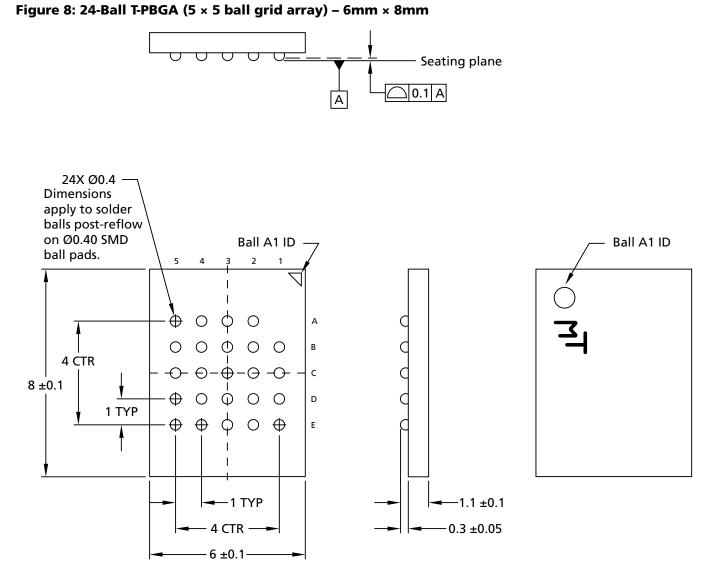


#### **Table 1: Signal Descriptions (Continued)**

Symbol	Туре	escription	
V <sub>SS</sub>	Supply	Core and I/O ground connection.	
DNU	-	<b>Do not use:</b> Do not connect to any other signal, or power supply; must be left floating.	
RFU	_	<b>Reserved for future use:</b> Reserved by Micron for future device functionality and enhance- ment. Recommend that these be left floating. May be connected internally, but external con- nections will not affect operation.	
NC	-	No connect : No internal connection; can be driven or floated.	



### Package Dimensions – Package Code: 12

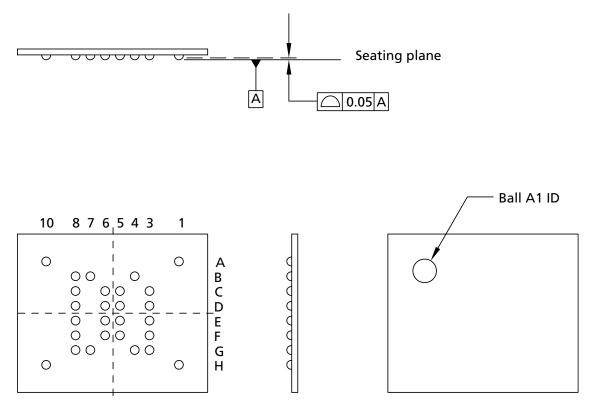


Notes: 1. All dimensions are in millimeters.2. See Part Number Ordering Information for complete package names and details.



### Package Dimensions – Package Code: 56

#### Figure 9: 27-Ball XFWLBGA

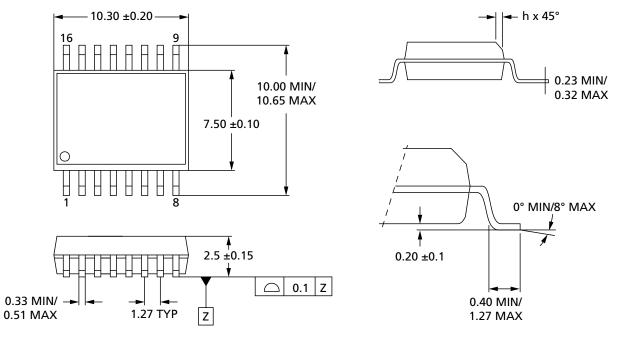


Note: 1. For detail information about this package option, contact the factory to request the data sheet addendum.



## Package Dimensions – Package Code: SF

#### Figure 10: 16-Pin SOP2 – 300 mil Body Width

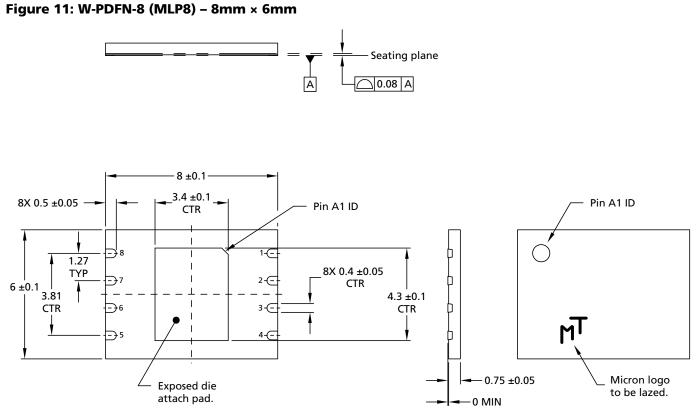


Notes: 1. All dimensions are in millimeters.

2. See Part Number Ordering Information for complete package names and details.



### Package Dimensions – Package Code: W9



Notes: 1. All dimensions are in millimeters.2. See Part Number Ordering Information for complete package names and details.



### Memory Map – 512Mb Density

#### Table 2: Memory Map

			Address Range			
Sector	Subsector (32KB)	Subsector (4KB)	Start	End		
1023	2047	16383	03FF F000h	03FF FFFFh		
		:	÷	÷		
		16376	03FF 8000h	03FF 8FFFh		
	2046	16375	03FF 7000h	03FF 7FFFh		
		÷	÷	:		
		16368	03FF 0000h	03FF 0FFFh		
÷	÷	÷	÷	:		
511	1023	8191	01FF F000h	01FF FFFFh		
		÷	÷	E		
		8184	01FF 8000h	01FF 8FFFh		
	1022	8183	01FF 7000h	01FF 7FFFh		
		:	÷	÷		
		8176	01FF 0000h	01FF 0FFFh		
÷	÷	÷	÷	E		
255	511	4095	00FF F000h	00FF FFFFh		
		÷	÷	:		
		4088	00FF 8000h	00FF 8FFFh		
	510	4087	00FF 7000h	00FF 7FFFh		
		÷	÷	:		
		4080	00FF 0000h	00FF 0FFFh		
:	:	:	÷	÷		
0	1	15	0000 F000h	0000 FFFFh		
		:	÷	÷		
		8	0000 8000h	0000 8FFFh		
	0	7	0000 7000h	0000 7FFFh		
		:	:	:		
		0	0000 0000h	0000 0FFFh		

Note: 1. See Part Number Ordering Information, Sector Size – Part Numbers table for options.



### **Status Register**

Status register bits can be read from or written to using READ STATUS REGISTER or WRITE STATUS REGISTER commands, respectively. When the status register enable/ disable bit (bit 7) is set to 1 and W# is driven LOW, the status register nonvolatile bits become read-only and the WRITE STATUS REGISTER operation will not execute. The only way to exit this hardware-protected mode is to drive W# HIGH.

#### **Table 3: Status Register**

Bit	Name	Settings	Description	Notes
7	Status register write enable/disa- ble	0 = Enabled (Default) 1 = Disabled	<b>Nonvolatile control bit:</b> Used with W# to enable or disable writing to the status register.	
5	Top/bottom	0 = Top (Default) 1 = Bottom	<b>Nonvolatile control bit:</b> Determines whether the pro- tected memory area defined by the block protect bits starts from the top or bottom of the memory array.	
6, 4:2	BP[3:0]	See Protected Area ta- bles	<b>Nonvolatile control bit:</b> Defines memory to be software protected against PROGRAM or ERASE operations. When one or more block protect bits is set to 1, a designated memory area is protected from PROGRAM and ERASE operations.	1
1	Write enable latch	0 = Clear (Default) 1 = Set	<b>Volatile control bit:</b> The device always powers up with this bit cleared to prevent inadvertent WRITE, PRO-GRAM, or ERASE operations. To enable these operations, the WRITE ENABLE operation must be executed first to set this bit.	
0	Write in progress	0 = Ready (Default) 1 = Busy	Volatile status bit: Indicates if one of the following command cycles is in progress: WRITE STATUS REGISTER WRITE NONVOLATILE CONFIGURATION REGISTER PROGRAM ERASE	2

Notes: 1. The BULK ERASE command is executed only if all bits = 0.

2. Status register bit 0 is the inverse of flag status register bit 7.



#### **Block Protection Settings**

#### **Table 4: Protected Area**

Status Register Content					Protected Area
Top/Bottom	BP3	BP2	BP1	BPO	64KB Sectors
0	0	0	0	0	None
0	0	0	0	1	1023:1023
0	0	0	1	0	1023:1022
0	0	0	1	1	1023:1020
0	0	1	0	0	1023:1016
0	0	1	0	1	1023:1008
0	0	1	1	0	1023:992
0	0	1	1	1	1023:960
0	1	0	0	0	1023:896
0	1	0	0	1	1023:768
0	1	0	1	0	1023:512
0	1	0	1	1	1023:0
0	1	1	0	0	1023:0
0	1	1	0	1	1023:0
0	1	1	1	0	1023:0
0	1	1	1	1	1023:0
1	0	0	0	0	None
1	0	0	0	1	0:0
1	0	0	1	0	1:0
1	0	0	1	1	3:0
1	0	1	0	0	7:0
1	0	1	0	1	15:0
1	0	1	1	0	31:0
1	0	1	1	1	63:0
1	1	0	0	0	127:0
1	1	0	0	1	255:0
1	1	0	1	0	511:0
1	1	0	1	1	1023:0
1	1	1	0	0	1023:0
1	1	1	0	1	1023:0
1	1	1	1	0	1023:0
1	1	1	1	1	1023:0



### **Flag Status Register**

Flag status register bits are read by using READ FLAG STATUS REGISTER command. All bits are volatile and are reset to zero on power-up.

Status bits are set and reset automatically by the internal controller. Error bits must be cleared through the CLEAR STATUS REGISTER command.

Bit	Name	Settings	Description
7	Program or erase controller	0 = Busy 1 = Ready	<b>Status bit:</b> Indicates whether one of the following command cycles is in progress: WRITE STATUS REGISTER, WRITE NONVOLATILE CONFIGURATION REGISTER, PROGRAM, or ERASE.
6	Erase suspend	0 = Clear 1 = Suspend	<b>Status bit:</b> Indicates whether an ERASE operation has been or is going to be suspended.
5	Erase	0 = Clear 1 = Failure or protection error	<b>Error bit:</b> Indicates whether an ERASE operation has succeeded or failed.
4	Program	0 = Clear 1 = Failure or protection error	<b>Error bit:</b> Indicates whether a PROGRAM operation has succeeded or failed. It indicates, also, whether a CRC check has succeeded or failed.
3	Reserved	0	Reserved
2	Program sus- pend	0 = Clear 1 = Suspend	<b>Status bit:</b> Indicates whether a PROGRAM operation has been or is going to be suspended.
1	Protection	0 = Clear 1 = Failure or protection error	<b>Error bit:</b> Indicates whether an ERASE or PROGRAM operation has attempted to modify the protected array sector, or whether a PROGRAM operation has attempted to access the locked OTP space.
0	Addressing	0 = 3-byte addressing 1 = 4-byte addressing	<b>Status bit:</b> Indicates whether 3-byte or 4-byte address mode is enabled.

#### **Table 5: Flag Status Register**



### **Extended Address Register**

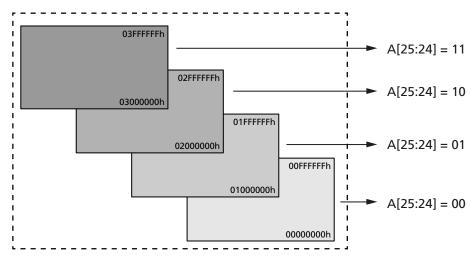
The 3-byte address mode can only access 128Mb of memory. To access the full device in 3-byte address mode, the device includes an extended address register that indirectly provides a fourth address byte A[31:24]. The extended address register bits [1:0] operate as memory address bit A[25:24] to select one of the four 128Mb segments of the memory array.

If 4-byte addressing is enabled, the extended address register settings are ignored.

#### **Table 6: Extended Address Register**

Bit	Name	Settings	Description
7:2	A[31:26]	000000	Reserved
1:0	A[25:24]	01 = Second 128Mb segment	Enables specified 128Mb memory segment. The de- fault (lowest) setting can be changed to the high- est 128Mb segment using bit 1 of the nonvolatile configuration register.

#### **Figure 12: Memory Array Segments**



The PROGRAM and ERASE operations act upon the 128Mb segment selected in the extended address register. The BULK ERASE operation erases the entire device.

The READ operation begins reading in the selected 128Mb segment, but is not bound by it.

In a continuous READ, when the last byte of the segment is read, the next byte output is the first byte of the next segment. The operation wraps to 0000000h; therefore, a download of the whole array is possible with one READ operation.

The value of the extended address register does not change when a READ operation crosses the selected 128Mb boundary.



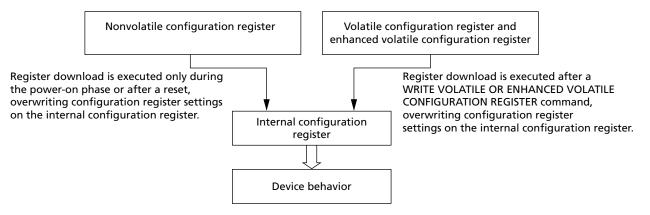
### **Internal Configuration Register**

The memory configuration is set by an internal configuration register that is not directly accessible to users.

The user can change the default configuration at power up by using the WRITE NON-VOLATILE CONFIGURATION REGISTER. Information from the nonvolatile configuration register overwrites the internal configuration register during power-on or after a reset.

The user can change the configuration during operation by using the WRITE VOLATILE CONFIGURATION REGISTER or the WRITE ENHANCED VOLATILE CONFIGURATION REGISTER commands. Information from the volatile configuration registers overwrite the internal configuration register immediately after the WRITE command completes.

#### **Figure 13: Internal Configuration Register**





### **Nonvolatile Configuration Register**

This register is read from and written to using the READ NONVOLATILE CONFIGURA-TION REGISTER and the WRITE NONVOLATILE CONFIGURATION REGISTER commands, respectively. A register download is executed during power-on or after reset, overwriting the internal configuration register settings that determine device behavior.

#### **Table 7: Nonvolatile Configuration Register**

Bit	Name	Settings	Description	Notes
15:12	Number of dummy clock cy- cles	0000 = Identical to 1111 0001 = 1 0010 = 2 : 1101 = 13 1110 = 14 1111 = Default	Sets the number of dummy clock cycles subse- quent to all FAST READ commands. (See the Command Set Table for default setting values.)	1
11:9	XIP mode at power-on reset000 = XIP: Fast read 001 = XIP: Dual output fast read 010 = XIP: Dual I/O fast read 011 = XIP: Quad output fast read 100 = XIP: Quad i/O fast read 101 = Reserved 110 = Reserved 111 = Disabled (Default)Enables the device to operate in the selected XIP mode immediately after power-on reset.			
8:6	Output driver strength	000 = Reserved 001 = 90 Ohms 010 = Reserved 011 = 45 Ohms 100 = Reserved 101 = 20 Ohms 110 = Reserved 111 = 30 Ohms (Default)	Optimizes the impedance at V <sub>CC</sub> /2 output volt- age.	
5	Double transfer rate protocol	0 = Enabled 1 = Disabled (Default)	Set DTR protocol as current one. Once enabled, all commands will work in DTR.	
4	Reset/hold	0 = Disabled 1 = Enabled (Default)	Enables or disables HOLD# or RESET# on DQ3.	
3	3Quad I/O0 = Enabledprotocol1 = Disabled (Default)		Enables or disables quad I/O command input (4-4-4 mode).	2
2			Enables or disables dual I/O command input (2-2-2 mode).	2
1	128Mb segment select	0 = Highest 128Mb segment 1 = Lowest 128Mb segment (De- fault)	Selects the power-on default 128Mb segment for 3-byte address operations. See also the extended address register.	



#### Table 7: Nonvolatile Configuration Register (Continued)

Bit	Name	Settings	Description	Notes
0	Number of	0 = Enable 4-byte address mode	Defines the number of address bytes for a com-	
	address bytes	1 = Enable 3-byte address mode	mand.	
	during command	(Default)		
	entry			

Notes: 1. The number of cycles must be set to accord with the clock frequency, which varies by the type of FAST READ command (See Supported Clock Frequencies table). Insufficient dummy clock cycles for the operating frequency causes the memory to read incorrect data.

2. When bits 2 and 3 are both set to 0, the device operates in quad I/O protocol.



### **Volatile Configuration Register**

This register is read from and written to by the READ VOLATILE CONFIGURATION REGISTER and the WRITE VOLATILE CONFIGURATION REGISTER commands, respectively. A register download is executed after these commands, overwriting the internal configuration register settings that determine device memory behavior.

#### **Table 8: Volatile Configuration Register**

Bit	Name	Settings	Description	Notes
7:4	Number of dummy clock cycles	0000 = Identical to 1111 0001 = 1 0010 = 2 : 1101 = 13 1110 = 14 1111 = Default	Sets the number of dummy clock cycles subsequent to all FAST READ commands. (See the Command Set Table for default setting values.)	1
3	XIP	0 = Enable 1 = Disable (Default)	Enables or disables XIP.	
2	Reserved	0	0b = Fixed value.	
1:0	Wrap	00 = 16-byte boundary aligned	16-byte wrap: Output data wraps within an aligned 16-byte boundary starting from the 3-byte address issued after the command code.	2
		01 = 32-byte boundary aligned	32-byte wrap: Output data wraps within an aligned 32-byte boundary starting from the 3-byte address issued after the command code.	
		10 = 64-byte boundary aligned	64-byte wrap: Output data wraps within an aligned 64-byte boundary starting from the 3-byte address issued after the command code.	
		11 = Continuous (Default)	Continuously sequences addresses through the entire array.	

- Notes: 1. The number of cycles must be set according to and sufficient for the clock frequency, which varies by the type of FAST READ command, as shown in the Supported Clock Frequencies table. An insufficient number of dummy clock cycles for the operating frequency causes the memory to read incorrect data.
  - 2. See the Sequence of Bytes During Wrap table.

#### **Table 9: Sequence of Bytes During Wrap**

Starting Address	16-Byte Wrap	32-Byte Wrap	64-Byte Wrap
0	0-1-215-0-1	0-1-231-0-1	0-1-263-0-1
1	1-215-0-1-2	1-231-0-1-2	1-263-0-1-2
15	15-0-1-2-315-0-1	15-16-1731-0-1	15-16-1763-0-1
31	-	31-0-1-2-331-0-1	31-32-3363-0-1
63	-	-	63-0-163-0-1



#### **Supported Clock Frequencies**

#### Table 10: Clock Frequencies – STR (in MHz) for IT and AT part

Notes apply to entire table

Number of Dummy Clock Cycles	FAST READ	DUAL OUTPUT FAST READ	DUAL I/O FAST READ	QUAD OUTPUT FAST READ	QUAD I/O FAST READ
1	94	79	60	44	39
2	112	97	77	61	48
3	129	106	86	78	58
4	146	115	97	97	69
5	162	125	106	106	78
6	166	134	115	115	86
7	166	143	125	125	97
8	166	152	134	134	106
9	166	162	143	143	115
10	166	166	152	152	125
11	166	166	162	162	134
12	166	166	166	166	143
13	166	166	166	166	156
14	166	166	166	166	166

Notes: 1. Values are guaranteed by characterization and not 100% tested in production.

2. A tuning data pattern (TDP) capability provides applications with data patterns for adjusting the data latching point at the host end when the clock frequency is set higher than 133 MHz in STR mode and higher than 66 MHz in double transfer rate (DTR) mode. For additional details, refer to TN-25-07: Tuning Data Pattern for MT25Q and MT25T Devices.

#### Table 11: Clock Frequencies – STR (in MHz) for UT part

Notes apply to entire table

Number of Dummy Clock Cycles	FAST READ	DUAL OUTPUT FAST READ	DUAL I/O FAST READ	QUAD OUTPUT FAST READ	QUAD I/O FAST READ
1	94	79	60	44	39
2	112	97	77	61	48
3	129	106	86	78	58
4	146	115	97	97	69
5	162	125	106	106	78
6	166	134	115	115	86
7	166	143	125	125	97
8	166	152	134	133	106
9	166	162	143	133	115

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#### Table 11: Clock Frequencies – STR (in MHz) for UT part (Continued)

Notes apply to entire table

Number of Dummy Clock Cycles	FAST READ	DUAL OUTPUT FAST READ	DUAL I/O FAST READ	QUAD OUTPUT FAST READ	QUAD I/O FAST READ
10	166	166	152	133	125
11	166	166	162	133	133
12	166	166	166	133	133
13	166	166	166	133	133
14	166	166	166	133	133

Notes: 1. Values are guaranteed by characterization and not 100% tested in production.

2. A tuning data pattern (TDP) capability provides applications with data patterns for adjusting the data latching point at the host end when the clock frequency is set higher than 133 MHz in STR mode and higher than 66 MHz in double transfer rate (DTR) mode. For additional details, refer to TN-25-07: Tuning Data Pattern for MT25Q and MT25T Devices.



#### Table 12: Clock Frequencies – DTR (in MHz) for IT and AT part

Notes apply to entire table

Number of Dummy Clock Cycles	FAST READ	DUAL OUTPUT FAST READ	DUAL I/O FAST READ	QUAD OUTPUT FAST READ	QUAD I/O FAST READ
1	59	45	40	26	20
2	73	59	49	40	30
3	82	68	59	59	39
4	90	76	65	65	49
5	90	83	75	75	58
6	90	90	83	83	68
7	90	90	90	90	78
8	90	90	90	90	85
9	90	90	90	90	90
10 : 14	90	90	90	90	90

Notes: 1. Values are guaranteed by characterization and not 100% tested in production.

2. A tuning data pattern (TDP) capability provides applications with data patterns for adjusting the data latching point at the host end when the clock frequency is set higher than 133 MHz in STR mode and higher than 66 MHz in double transfer rate (DTR) mode. For additional details, refer to TN-25-07: Tuning Data Pattern for MT25Q and MT25T Devices.



#### Table 13: Clock Frequencies - DTR (in MHz) for UT part

#### Notes apply to entire table

Number of Dummy Clock Cycles	FAST READ	DUAL OUTPUT FAST READ	DUAL I/O FAST READ	QUAD OUTPUT FAST READ	QUAD I/O FAST READ
1	59	45	40	26	20
2	73	59	49	40	30
3	82	68	59	59	39
4	90	76	65	65	49
5	90	83	75	75	58
6	90	90	83	80	68
7	90	90	90	80	78
8	90	90	90	80	80
9	90	90	90	80	80
10 : 14	90	90	90	80	80

Notes: 1. Values are guaranteed by characterization and not 100% tested in production.

2. A tuning data pattern (TDP) capability provides applications with data patterns for adjusting the data latching point at the host end when the clock frequency is set higher than 133 MHz in STR mode and higher than 66 MHz in double transfer rate (DTR) mode. For additional details, refer to TN-25-07: Tuning Data Pattern for MT25Q and MT25T Devices.



### **Enhanced Volatile Configuration Register**

This register is read from and written to using the READ ENHANCED VOLATILE CON-FIGURATION REGISTER and the WRITE ENHANCED VOLATILE CONFIGURATION REGISTER commands, respectively. A register download is executed after these commands, overwriting the internal configuration register settings that determine device memory behavior.

#### **Table 14: Enhanced Volatile Configuration Register**

Bit	Name	Settings	Description	Notes
7	Quad I/O protocol	0 = Enabled 1 = Disabled (Default)	Enables or disables quad I/O command input (4-4-4 mode).	1
6	Dual I/O protocol	0 = Enabled 1 = Disabled (Default)	Enables or disables dual I/O command input (2-2-2 mode).	1
5	Double transfer rate protocol	0 = Enabled 1 = Disabled (Default, single transfer rate)	Set DTR protocol as current one. Once enabled, all commands will work in DTR.	
4	Reset/hold	0 = Disabled 1 = Enabled (Default)	Enables or disables HOLD# or RESET# on DQ3. (Available only on specified part numbers.)	
3	Reserved	1		
2:0	Output driver strength	000 = Reserved 001 = 90 ohms 010 = Reserved 011 = 45 ohms 100 = Reserved 101 = 20 ohms 110 = Reserved 111 = 30 ohms (De- fault)	Optimizes the impedance at V <sub>CC</sub> /2 output voltage.	

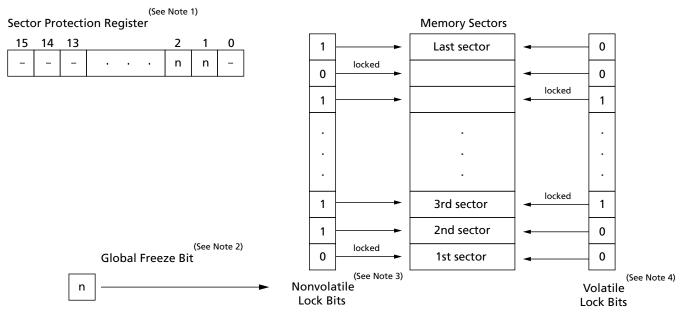
Note: 1. When bits 6 and 7 are both set to 0, the device operates in quad I/O protocol. When either bit 6 or 7 is set to 0, the device operates in dual I/O or quad I/O respectively. When a bit is set, the device enters the selected protocol immediately after the WRITE ENHANCED VOLATILE CONFIGURATION REGISTER command. The device returns to the default protocol after the next power-on or reset. Also, the rescue sequence or another WRITE ENHANCED VOLATILE CONFIGURATION REGISTER command will return the device to the default protocol.



### **Security Registers**

Security registers enable sector and password protection on multiple levels using nonvolatile and volatile register and bit settings (shown below). The applicable register tables follow.

#### **Figure 14: Sector and Password Protection**



- Notes: 1. **Sector protection register.** This 16-bit nonvolatile register includes two active bits[2:1] to enable sector and password protection.
  - 2. Global freeze bit. This volatile bit protects the settings in all nonvolatile lock bits.
  - 3. **Nonvolatile lock bits.** Each nonvolatile bit corresponds to and provides nonvolatile protection for an individual memory sector, which remains locked (protection enabled) until its corresponding bit is cleared to 1.
  - 4. **Volatile lock bits.** Each volatile bit corresponds to and provides volatile protection for an individual memory sector, which is locked temporarily (protection is cleared when the device is reset or powered down).
  - 5. The first and last sectors will have volatile protections at the 4KB subsector level. Each 4KB subsector in these sectors can be individually locked by volatile lock bits setting; nonvolatile protections granularity remain at the sector level.



### **Sector Protection Security Register**

#### **Table 15: Sector Protection Register**

Bits	Name	Settings	Description	Notes
15:3	Reserved	1 = Default	-	
2	Password protection lock	1 = Disabled (Default) 0 = Enabled	<b>Nonvolatile bit:</b> When set to 1, password protection is disabled. When set to 0, password protection is enabled permanently; the 64-bit password cannot be retrieved or reset.	1, 2
1	Sector protection lock	<ul> <li>1 = Enabled, with password protection (Default)</li> <li>0 = Enabled, without password protection</li> </ul>	Nonvolatile bit: When set to 1, nonvolatile lock bits can be set to lock/unlock their corresponding memory sectors; bit 2 can be set to 0, enabling password protection perma- nently. When set to 0, nonvolatile lock bits can be set to lock/ unlock their corresponding memory sectors; bit 2 must re- main set to 1, disabling password protection permanently.	1, 3, 4
0	Reserved	1 = Default	-	

- Notes: 1. Bits 2 and 1 are user-configurable, one-time-programmable, and mutually exclusive in that only one of them can be set to 0. It is recommended that one of the bits be set to 0 when first programming the device.
  - 2. The 64-bit password must be programmed and verified before this bit is set to 0 because after it is set, password changes are not allowed, thus providing protection from malicious software. When this bit is set to 0, a 64-bit password is required to reset the global freeze bit from 0 to 1. In addition, if the password is incorrect or lost, the global freeze bit can no longer be set and nonvolatile lock bits cannot be changed. (See the Sector and Password Protection figure and the Global Freeze Bit Definition table).
  - 3. Whether this bit is set to 1 or 0, it enables programming or erasing nonvolatile lock bits (which provide memory sector protection). The password protection bit must be set beforehand because setting this bit will either enable password protection permanently (bit 2 = 0) or disable password protection permanently (bit 1 = 0).
  - 4. By default, all sectors are unlocked when the device is shipped from the factory. Sectors are locked, unlocked, read, or locked down as explained in the Nonvolatile and Volatile Lock Bits table and the Volatile Lock Bit Register Bit Definitions table.

#### **Table 16: Global Freeze Bit**

Bits	Name	Settings	Description
7:1	Reserved	0	Bit values are 0
0	Global freeze bit	1 = Disabled (Default) 0 = Enabled	<b>Volatile bit:</b> When set to 1, all nonvolatile lock bits can be set to enable or disable locking their corresponding memory sectors. When set to 0, nonvolatile lock bits are protected from PROGRAM or ERASE commands. This bit should not be set to 0 until the nonvolatile lock bits are set.

Note: 1. The READ GLOBAL FREEZE BIT command enables reading this bit. When password protection is enabled, this bit is locked upon device power-up or reset. It cannot be changed without the password. After the password is entered, the UNLOCK PASSWORD command resets this bit to 1, enabling programing or erasing the nonvolatile lock bits. After the bits are changed, the WRITE GLOBAL FREEZE BIT command sets this bit to 0, protecting the nonvolatile lock bits from PROGRAM or ERASE operations.



# **Nonvolatile and Volatile Sector Lock Bits Security**

### Table 17: Nonvolatile and Volatile Lock Bits

Bit Details	Nonvolatile Lock Bit	Volatile Lock Bit
Description	Each sector of memory has one corresponding non- volatile lock bit	Each sector of memory has one corresponding vola- tile lock bit; this bit is the sector write lock bit descri- bed in the Volatile Lock Bit Register table.
Function	When set to 0, locks and protects its corresponding memory sector from PROGRAM or ERASE operations. Because this bit is nonvolatile, the sector remains locked, protection enabled, until the bit is cleared to 1.	When set to 1, locks and protects its corresponding memory sector from PROGRAM or ERASE operations. Because this bit is volatile, protection is temporary. The sector is unlocked, protection disabled, upon de- vice reset or power-down.
Settings	1 = Lock disabled 0 = Lock enabled	0 = Lock disabled 1 = Lock enabled
Enabling protection	The bit is set to 0 by the WRITE NONVOLATILE LOCK BITS command, enabling protection for designated locked sectors. Programming a sector lock bit re- quires the typical byte programming time.	The bit is set to 1 by the WRITE VOLATILE LOCK BITS command, enabling protection for designated locked sectors.
Disabling protection	All bits are cleared to 1 by the ERASE NONVOLATILE LOCK BITS command, unlocking and disabling pro- tection for all sectors simultaneously. Erasing all sec- tor lock bits requires typical sector erase time.	All bits are set to 0 upon reset or power-down, un- locking and disabling protection for all sectors.
Reading the bit	Bits are read by the READ NONVOLATILE LOCK BITS command.	Bits are read by the READ VOLATILE LOCK BITS command.

# **Volatile Lock Bit Security Register**

One volatile lock bit register is associated with each sector of memory. It enables the sector to be locked, unlocked, or locked-down with the WRITE VOLATILE LOCK BITS command, which executes only when sector lock down (bit 1) is set to 0. Each register can be read with the READ VOLATILE LOCK BITS command. This register is compatible with and provides the same locking capability as the lock register in the Micron N25Q SPI NOR family.

### **Table 18: Volatile Lock Bit Register**

Bit	Name	Settings	Description
7:2	Reserved	0	Bit values are 0.
1	Sector lock down	0 = Lock-down disabled (Default) 1 = Lock-down enabled	<b>Volatile bit:</b> Device always powers up with this bit set to 0 so that sector lock down and sector write lock bits can be set to 1. When this bit set to 1, neither of the two volatile lock bits can be written to until the next power cycle, hardware, or software reset.
0	Sector write lock	0 = Write lock disabled (Default) 1 = Write lock enabled	<b>Volatile bit:</b> Device always powers up with this bit set to 0 so that PROGRAM and ERASE operations in this sector can be executed and sector content modified. When this bit is set to 1, PROGRAM and ERASE operations in this sector are not executed.



# **Device ID Data**

The device ID data shown in the tables here is read by the READ ID and MULTIPLE I/O READ ID operations.

### Table 19: Device ID Data

Byte#	Name	Content Value	Assigned By
Manufac	turer ID (1 byte total)		
1	Manufacturer ID (1 byte)	20h	JEDEC
Device ID	(2 bytes total)	•	
2	Memory Type (1 byte)	BAh = 3V	Manufacturer
		BBh = 1.8V	
3	Memory Capacity (1 byte)	22h = 2Gb	
		21h = 1Gb	
		20h = 512Mb	
		19h = 256Mb	
		18h = 128Mb	
		17h = 64Mb	
Unique II	(17 bytes total)	•	
4	Indicates the number of remaining ID bytes (1 byte)	10h	Factory
5	Extended device ID (1 byte)	See Extended Device ID table	
6	Device configuration information (1 byte)	00h = Standard	
7:20	Customized factory data (14 bytes)	Unique ID code (UID)	

### Table 20: Extended Device ID Data, First Byte

Bit 7	Bit 6	Bit 5 <sup>1</sup>	Bit 4	Bit 3	Bit 2 <sup>2</sup>	Bit 1	Bit 0
Reserved	Device Generation 1 = 2nd generation	1 = Alternate BP scheme 0 = Standard BP scheme	Reserved	HOLD#/RESET#: 0 = HOLD 1 = RESET	Additional HW RESET#: 1 = Available 0 = Not available	00 = U	r size: niform KB

Notes: 1. For alternate BP scheme information, contact the factory.

2. Available for specific part numbers. See Part Number Ordering Information for details.



## **Serial Flash Discovery Parameter Data**

The serial Flash discovery parameter (SFDP) provides a standard, consistent method to describe serial Flash device functions and features using internal parameter tables. The parameter tables can be interrogated by host system software, enabling adjustments to accommodate divergent features from multiple vendors. The SFDP standard defines a common parameter table that describes important device characteristics and serial access methods used to read the parameter table data.

Micron's SFDP table information aligns with JEDEC-standard JESD216 for serial Flash discoverable parameters. The latest JEDEC standard includes revision 1.6. Beginning week 42 (2014), Micron's MT25Q production parts will include SFDP data that aligns with revision 1.6.

Refer to JEDEC-standard JESD216B for a complete overview of the SFDP table definition.

Data in the SFDP tables is read by the READ SERIAL FLASH DISCOVERY PARAMETER operation.

See Micron TN-25-06: Serial Flash Discovery Parameters for MT25Q Family for serial Flash discovery parameter data.

# **Command Definitions**

### Table 21: Command Set

#### Notes 1 and 2 apply to the entire table

		Comma	nd-Addre	ss-Data		Dummy Clock Cycles				
Command	Code	Extended SPI	Dual SPI	Quad SPI	Address Bytes	Extended SPI	Dual SPI	Quad SPI	Data Bytes	Notes
Software RESET Operations					-	11			-	
RESET ENABLE	66h	1-0-0	2-0-0	4-0-0	0	0	0	0	0	-
RESET MEMORY	99h	1-0-0	2-0-0	4-0-0	0	0	0	0	0	-
READ ID Operations		1 1			-			•	•	
READ ID	9E/9Fh	1-0-1			0	0			1 to 20	-
MULTIPLE I/O READ ID	AFh	1-0-1	2-0-2	4-0-4	0	0	0	0	1 to 20	-
READ SERIAL FLASH DISCOVERY PARAMETER	5Ah	1-1-1	2-2-2	4-4-4	3	8	8	8	1 to ∞	3
READ MEMORY Operations				•	1					
READ	03h	1-1-1			3(4)	0			1 to ∞	4
FAST READ	0Bh	1-1-1	2-2-2	4-4-4	3(4)	8	8	10	1 to ∞	4, 5
DUAL OUTPUT FAST READ	3Bh	1-1-2	2-2-2		3(4)	8	8		1 to ∞	4, 5
DUAL INPUT/OUTPUT FAST READ	BBh	1-2-2	2-2-2		3(4)	8	8		1 to ∞	4, 5
QUAD OUTPUT FAST READ	6Bh	1-1-4		4-4-4	3(4)	8		10	1 to ∞	4, 5
QUAD INPUT/OUTPUT FAST READ	EBh	1-4-4		4-4-4	3(4)	10		10	1 to ∞	4, 5
DTR FAST READ	0Dh	1-1-1	2-2-2	4-4-4	3(4)	6	6	8	1 to ∞	4, 5
DTR DUAL OUTPUT FAST READ	3Dh	1-1-2	2-2-2		3(4)	6	6		1 to ∞	4, 5
DTR DUAL INPUT/OUTPUT FAST READ	BDh	1-2-2	2-2-2		3(4)	6	6		1 to ∞	4, 5
DTR QUAD OUTPUT FAST READ	6Dh	1-1-4		4-4-4	3(4)	6		8	1 to ∞	4, 5
DTR QUAD INPUT/OUTPUT FAST READ	EDh	1-4-4		4-4-4	3(4)	8		8	1 to ∞	4, 5
QUAD INPUT/OUTPUT WORD READ	E7h	1-4-4		4-4-4	3(4)	4		4	1 to ∞	4
<b>READ MEMORY Operations with</b>	n 4-Byte A	ddress		۰		· ·		4	4	
4-BYTE READ	13h	1-1-1			4	0			1 to ∞	5
4-BYTE FAST READ	0Ch	1-1-1	2-2-2	4-4-4	4	8	8	10	1 to ∞	5
4-BYTE DUAL OUTPUT FAST READ	3Ch	1-1-2	2-2-2		4	8	8		1 to ∞	5

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#### Notes 1 and 2 apply to the entire table

		Command-Address-Data				Dummy Clock Cycles				
Command	Code	Extended SPI	Dual SPI	Quad SPI	Address Bytes	Extended SPI	Dual SPI	Quad SPI	Data Bytes	Notes
4-BYTE DUAL INPUT/OUTPUT FAST READ	BCh	1-2-2	2-2-2		4	8	8		1 to ∞	5
4-BYTE QUAD OUTPUT FAST READ	6Ch	1-1-4		4-4-4	4	8		10	1 to ∞	5
4-BYTE QUAD INPUT/OUTPUT FAST READ	ECh	1-4-4		4-4-4	4	10		10	1 to ∞	5
4-BYTE DTR FAST READ	0Eh	1-1-1	2-2-2	4-4-4	4	6	6	8	1 to ∞	5
4-BYTE DTR DUAL INPUT/OUTPUT FAST READ	BEh	1-2-2	2-2-2		4	6	6		1 to ∞	5
4-BYTE DTR QUAD INPUT/ OUTPUT FAST READ	EEh	1-4-4		4-4-4	4	8		8	1 to ∞	5
WRITE Operations										
WRITE ENABLE	06h	1-0-0	2-0-0	4-0-0	0	0	0	0	0	-
WRITE DISABLE	04h	1-0-0	2-0-0	4-0-0	0	0	0	0	0	-
READ REGISTER Operations										
READ STATUS REGISTER	05h	1-0-1	2-0-2	4-0-4	0	0	0	0	1 to ∞	-
READ FLAG STATUS REGISTER	70h	1-0-1	2-0-2	4-0-4	0	0	0	0	1 to ∞	-
READ NONVOLATILE CONFIGU- RATION REGISTER	B5h	1-0-1	2-0-2	4-0-4	0	0	0	0	2 to ∞	-
READ VOLATILE CONFIGURATION REGISTER	85h	1-0-1	2-0-2	4-0-4	0	0	0	0	1 to ∞	-
READ ENHANCED VOLATILE CON- FIGURATION REGISTER	65h	1-0-1	2-0-2	4-0-4	0	0	0	0	1 to ∞	-
READ EXTENDED ADDRESS REG- ISTER	C8h	1-0-1	2-0-2	4-0-4	0	0	0	0	1 to ∞	-
READ GENERAL PURPOSE READ REGISTER	96h	1-0-1	2-0-2	4-0-4	0	8	8	8	1 to ∞	6, 7
WRITE REGISTER Operations										
WRITE STATUS REGISTER	01h	1-0-1	2-0-2	4-0-4	0	0	0	0	1	8
WRITE NONVOLATILE CONFIGU- RATION REGISTER	B1h	1-0-1	2-0-2	4-0-4	0	0	0	0	2	8

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41

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#### Notes 1 and 2 apply to the entire table

		Comma	nd-Addre	ss-Data		Dummy Clock Cycles				
Command	Code	Extended SPI	Dual SPI	Quad SPI	Address Bytes	Extended SPI	Dual SPI	Quad SPI	Data Bytes	Notes
WRITE VOLATILE CONFIGURA- TION REGISTER	81h	1-0-1	2-0-2	4-0-4	0	0	0	0	1	8
WRITE ENHANCED VOLATILE CONFIGURATION REGISTER	61h	1-0-1	2-0-2	4-0-4	0	0	0	0	1	8
WRITE EXTENDED ADDRESS REG- ISTER	C5h	1-0-1	2-0-2	4-0-4	0	0	0	0	1	8
CLEAR FLAG STATUS REGISTER	Operation	1 1		1	1				1	1
CLEAR FLAG STATUS REGISTER	50h	1-0-0	2-0-0	4-0-0	0	0	0	0	0	-
PROGRAM Operations										
PAGE PROGRAM	02h	1-1-1	2-2-2	4-4-4	3(4)	0	0	0	1 to 256	8
DUAL INPUT FAST PROGRAM	A2h	1-1-2	2-2-2		3(4)	0	0		1 to 256	4, 8
EXTENDED DUAL INPUT FAST PROGRAM	D2h	1-2-2	2-2-2		3(4)	0	0		1 to 256	4, 8
QUAD INPUT FAST PROGRAM	32h	1-1-4		4-4-4	3(4)	0		0	1 to 256	4, 8
EXTENDED QUAD INPUT FAST PROGRAM	38h	1-4-4		4-4-4	3(4)	0		0	1 to 256	4, 8
PROGRAM Operations with 4-B	yte Addres	s								
4-BYTE PAGE PROGRAM	12h	1-1-1	2-2-2	4-4-4	4	0	0	0	1 to 256	8
4-BYTE QUAD INPUT FAST PRO- GRAM	34h	1-1-4		4-4-4	4	0		0	1 to 256	8
4-BYTE QUAD INPUT EXTENDED FAST PROGRAM	3Eh	1-4-4		4-4-4	4	0		0	1 to 256	8
ERASE Operations	1			1						
32KB SUBSECTOR ERASE	52h	1-1-0	2-2-0	4-4-0	3(4)	0	0	0	0	4, 8
4KB SUBSECTOR ERASE	20h	1-1-0	2-2-0	4-4-0	3(4)	0	0	0	0	4, 8
SECTOR ERASE	D8h	1-1-0	2-2-0	4-4-0	3(4)	0	0	0	0	4, 8
BULK ERASE	C7h/60h	1-0-0	2-0-0	4-0-0	0	0	0	0	0	8
ERASE Operations with 4-Byte	Address									
4-BYTE SECTOR ERASE	DCh	1-1-0	2-2-0	4-4-0	4	0	0	0	0	8
4-BYTE 4KB SUBSECTOR ERASE	21h	1-1-0	2-2-0	4-4-0	4	0	0	0	0	8
4-BYTE 32KB SUBSECTOR ERASE	5Ch	1-1-0	2-2-0	4-4-0	4	0	0	0	0	8



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#### Notes 1 and 2 apply to the entire table

		Comma	nd-Addre	ss-Data		Dummy Clock Cycles				
Command	Code	Extended SPI	Dual SPI	Quad SPI	Address Bytes	Extended SPI	Dual SPI	Quad SPI	Data Bytes	Notes
SUSPEND/RESUME Operations	<u></u>	-II-		<u></u>	1	II.		1	ļ	1
PROGRAM/ERASE SUSPEND	75h	1-0-0	2-0-0	4-0-0	0	0	0	0	0	-
PROGRAM/ERASE RESUME	7Ah	1-0-0	2-0-0	4-0-0	0	0	0	0	0	_
ONE-TIME PROGRAMMABLE (OT	P) Operat	ions		Į	1	II		1	ļ	1
READ OTP ARRAY	4Bh	1-1-1	2-2-2	4-4-4	3(4)	8	8	10	1 to 64	4, 5
PROGRAM OTP ARRAY	42h	1-1-1	2-2-2	4-4-4	3(4)	0	0	0	1 to 64	4, 8
4-BYTE ADDRESS MODE Operat	ions	1 1		Į	4			1	ł	1
ENTER 4-BYTE ADDRESS MODE	B7h	1-0-0	2-0-0	4-0-0	0	0	0	0	0	_
EXIT 4-BYTE ADDRESS MODE	E9h	1-0-0	2-0-0	4-0-0	0	0	0	0	0	_
QUAD PROTOCOL Operations	Į	1 1		Į	4			1	ł	1
ENTER QUAD INPUT/OUTPUT MODE	35h	1-0-0	2-0-0	4-0-0	0	0	0	0	0	-
RESET QUAD INPUT/OUTPUT MODE	F5h	1-0-0	2-0-0	4-0-0	0	0	0	0	0	-
Deep Power-Down Operations				<u>.</u>	1	II.			1	
ENTER DEEP POWER DOWN	B9h	1-0-0	2-0-0	4-0-0	0	0	0	0	0	-
RELEASE FROM DEEP POWER- DOWN	ABh	1-0-0	2-0-0	4-0-0	0	0	0	0	0	-
ADVANCED SECTOR PROTECTIO	N Operatio	ons		Į	1	II		1	ļ	1
READ SECTOR PROTECTION	2Dh	1-0-1	2-0-2	4-0-4	0	0	0	0	1 to ∞	-
PROGRAM SECTOR PROTECTION	2Ch	1-0-1	2-0-2	4-0-4	0	0	0	0	2	8
READ VOLATILE LOCK BITS	E8h	1-1-1	2-2-2	4-4-4	3(4)	0	0	0	1 to ∞	4, 9
WRITE VOLATILE LOCK BITS	E5h	1-1-1	2-2-2	4-4-4	3(4)	0	0	0	1	4, 8, 10
READ NONVOLATILE LOCK BITS	E2h	1-1-1	2-2-2	4-4-4	4	0	0	0	1 to ∞	_
WRITE NONVOLATILE LOCK BITS	E3h	1-1-0	2-2-0	4-4-0	4	0	0	0	0	8
ERASE NONVOLATILE LOCK BITS	E4h	1-0-0	2-0-0	4-0-0	0	0	0	0	0	8
READ GLOBAL FREEZE BIT	A7h	1-0-1			0	0	0	0	1 to ∞	-
WRITE GLOBAL FREEZE BIT	A6h	1-0-0	2-0-0	4-0-0	0	0	0	0	0	8
READ PASSWORD	27h	1-0-1			0	0	0	0	1 to ∞	-
WRITE PASSWORD	28h	1-0-1	2-0-2	4-0-4	0	0	0	0	8	8

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43

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#### Notes 1 and 2 apply to the entire table

		Comma	and-Addres	ss-Data		Dumr	ny Clock C	Cycles		
		Extended	Dual	Quad	Address	Extended	Dual	Quad	Data	
Command	Code	SPI	SPI	SPI	Bytes	SPI	SPI	SPI	Bytes	Notes
UNLOCK PASSWORD	29h	1-0-1	2-0-2	4-0-4	0	0	0	0	8	-
ADVANCED SECTOR PROTECTION Operations with 4-Byte Address										
4-BYTE READ VOLATILE LOCK	E0h	1-1-1	2-2-2	4-4-4	4	0	0	0	1 to ∞	_
BITS										
4-BYTE WRITE VOLATILE LOCK	E1h	1-1-1	2-2-2	4-4-4	4	0	0	0	1	8
BITS										
ADVANCED FUNCTION INTERFA	ADVANCED FUNCTION INTERFACE Operations									
INTERFACE ACTIVATION	9Bh	1-0-0	2-0-0	4-0-0	0	0	0	0	0	-
CYCLIC REDUNDANCY CHECK	9Bh/27h	1-0-1	2-0-2	4-0-4	0	0	0	0	10 or 18	-



512Mb, 1.8V Multiple I/O Serial Flash Memory Command Definitions



- Notes: 1. Micron extended SPI protocol is the standard SPI protocol with additional commands that extend functionality and enable address or data transmission on multiple DQn lines.
  - 2. The command code is always transmitted on DQn = 1, 2, or 4 lines according to the standard, dual, or quad protocol respectively. However, a command may be able to transmit address and data on multiple DQn lines regardless of protocol. The protocol columns show the number of DQn lines a command uses to transmit command, address, and data information as shown in these examples: command-address-data = 1-1-1, or 1-2-2, or 2-4-4, and so on.
  - 3. The READ SERIAL FLASH DISCOVERY PARAMETER operation accepts only 3-byte address even if the device is configured to 4-byte address mode.
  - 4. Requires 4 bytes of address if the device is configured to 4-byte address mode.
  - 5. The number of dummy clock cycles required when shipped from Micron factories. The user can modify the dummy clock cycle number via the nonvolatile configuration register and the volatile configuration register.
  - 6. The number of dummy cycles for the READ GENERAL PURPOSE READ REGISTER command is fixed (8 dummy cycles) and is not affected by dummy cycle settings in the nonvolatile configuration register and volatile configuration register.
  - 7. The general purpose read register is 64 bytes. After the first 64 bytes, the device outputs 00h and does not wrap.
  - 8. The WRITE ENABLE command must be issued first before this operation can be executed.
  - 9. Formerly referred to as the READ LOCK REGISTER operation.
  - 10. Formerly referred to as the WRITE LOCK REGISTER operation.



# **Software RESET Operations**

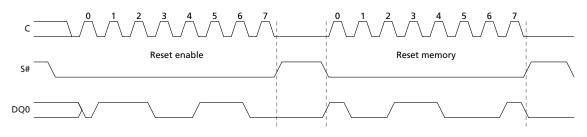
### **RESET ENABLE and RESET MEMORY Commands**

To initiate these commands, S# is driven LOW and the command code is input on DQn. A minimum de-selection time of <sup>t</sup>SHSL2 must come between RESET ENABLE and RE-SET MEMORY or reset is not guaranteed. Then, S# must be driven HIGH for the device to enter power-on reset. A time of <sup>t</sup>SHSL3 is required before the device can be re-selected by driving S# LOW.

### Table 22: RESET ENABLE and RESET MEMORY Operations

Operation Name	Description/Conditions
RESET ENABLE (66h)	To reset the device, the RESET ENABLE command must be followed by the RESET MEMORY
RESET MEMORY (99h)	command. When the two commands are executed, the device enters a power-on reset con- dition. It is recommended to exit XIP mode before executing these two commands. All volatile lock bits, the volatile configuration register, the enhanced volatile configura- tion register, and the extended address register are reset to the power-on reset default condition according to nonvolatile configuration register settings. If a reset is initiated while a WRITE, PROGRAM, or ERASE operation is in progress or sus- pended, the operation is aborted and data may be corrupted. Reset is effective after the flag status register bit 7 outputs 1 with at least one byte output. A RESET ENABLE command is not accepted during WRITE STATUS REGISTER and WRITE NONVOLATILE CONFIGURATION REGISTER operations.

### Figure 15: RESET ENABLE and RESET MEMORY Command



Note: 1. Above timing diagram is showed for Extended-SPI Protocol case, however these commands are available in all protocols. In DIO-SPI protocol, the instruction bits are transmitted on both DQ0 and DQ1 pins. In QIO-SPI protocol the instruction bits are transmitted on all four data pins. In Extended-DTR-SPI protocol, the instruction bits are transmitted on DQ0 pin in double transfer rate mode. In DIO-DTR-SPI protocol, the instruction bits are transmitted on both DQ0 and DQ1 pins in double transfer rate mode. In QIO-DTR-SPI protocol, the instruction bits are transmitted on all four data pins in double transfer rate mode.



# **READ ID Operations**

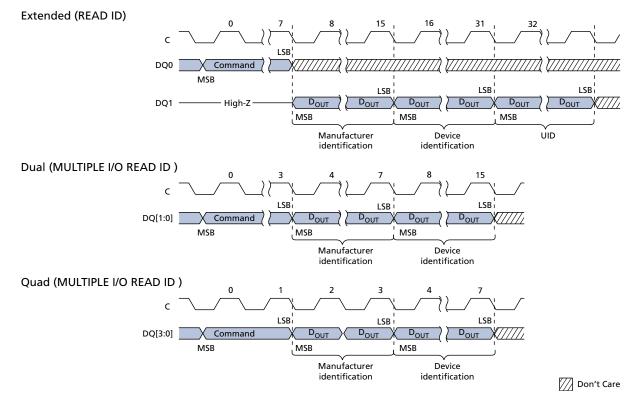
## **READ ID and MULTIPLE I/O READ ID Commands**

To initiate these commands, S# is driven LOW and the command code is input on DQ*n*. When S# is driven HIGH, the device goes to standby. The operation is terminated by driving S# HIGH at any time during data output.

### Table 23: READ ID and MULTIPLE I/O READ ID Operations

Operation Name	Description/Conditions
	Outputs information shown in the Device ID Data tables. If an ERASE or PROGRAM cycle is
	in progress when the command is initiated, the command is not decoded and the com- mand cycle in progress is not affected.

### Figure 16: READ ID and MULTIPLE I/O READ ID Commands



Note: 1. S# not shown.

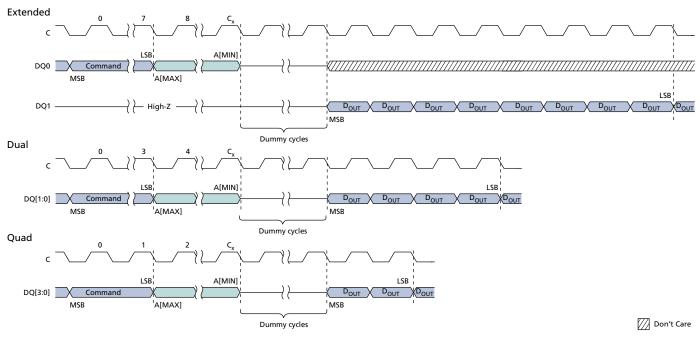


# **READ SERIAL FLASH DISCOVERY PARAMETER Operation**

## **READ SERIAL FLASH DISCOVERY PARAMETER Command**

To execute READ SERIAL FLASH DISCOVERY PARAMETER command, S# is driven LOW. The command code is input on DQ0, followed by three address bytes and eight dummy clock cycles (address is always 3 bytes, even if the device is configured to work in 4-byte address mode). The device outputs the information starting from the specified address. When the 2048-byte boundary is reached, the data output wraps to address 0 of the serial Flash discovery parameter table. The operation is terminated by driving S# HIGH at any time during data output.

**Note:** The operation always executes in continuous mode so the read burst wrap setting in the volatile configuration register does not apply.



### Figure 17: READ SERIAL FLASH DISCOVERY PARAMETER Command – 5Ah

- Notes: 1. For extended protocol,  $C_x = 7 + (A[MAX] + 1)$ ; For dual protocol,  $C_x = 3 + (A[MAX] + 1)/2$ ; For quad protocol,  $C_x = 1 + (A[MAX] + 1)/4$ .
  - 2. S# not shown.



# **READ MEMORY Operations**

To initiate a command, S# is driven LOW and the command code is input on DQ*n*, followed by input of the address bytes on DQ*n*. The operation is terminated by driving S# HIGH at any time during data output.

### **Table 24: READ MEMORY Operations**

Operation Name	Description/Conditions					
READ (03h)	The device supports 3-byte addressing (default), with A[23:0] input during					
FAST READ (0Bh)	address cycle. After any READ command is executed, the device will out-					
DUAL OUTPUT FAST READ (3Bh)	put data from the selected address. After the boundary is reached, the device will start reading again from the beginning.					
DUAL INPUT/OUTPUT FAST READ (BBh)	Each address bit is latched in during the rising edge of the clock. The ad-					
QUAD OUTPUT FAST READ (6Bh)	dressed byte can be at any location, and the address automatically incre-					
QUAD INPUT/OUTPUT FAST READ (EBh)	ments to the next address after each byte of data is shifted out; there-					
DTR FAST READ (0Dh)	fore, a die can be read with a single command. FAST READ can operate at a higher frequency ( <sup>f</sup> C).					
DTR DUAL OUTPUT FAST READ (3Dh)	DTR commands function in DTR protocol regardless of settings in the					
DTR DUAL INPUT/OUTPUT FAST READ (BDh)	nonvolatile configuration register or enhanced volatile configuration reg-					
DTR QUAD OUTPUT FAST READ (6Dh)	ister; other commands function in DTR protocol only after DTR protocol is					
DTR QUAD INPUT/OUTPUT FAST READ (EDh)	enabled by the register settings.					
QUAD INPUT/OUTPUT WORD READ (E7h)	E7h is similar to the QUAD I/O FAST READ command except that the low- est address bit (A0) must equal 0 and only four dummy clocks are re- quired prior to the data output. This command is supported in extended- SPI and quad-SPI protocols, but not in the DTR protocol; it is ignored it in					
	dual-SPI protocol.					



# **4-BYTE READ MEMORY Operations**

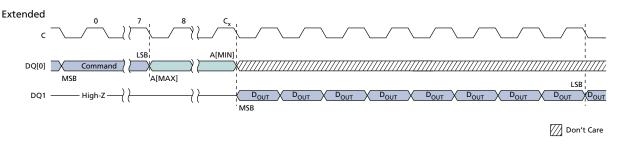
### Table 25: 4-BYTE READ MEMORY Operations

Operation Name	Description/Conditions
4-BYTE READ (13h)	READ MEMORY operations can be extended to a 4-byte address range,
4-BYTE FAST READ (0Ch)	with [A31:0] input during address cycle.
4-BYTE DUAL OUTPUT FAST READ (3Ch)	Selection of the 3-byte or 4-byte address range can be enabled in two ways: through the nonvolatile configuration register or through the ENA-
4-BYTE DUAL INPUT/OUTPUT FAST READ (BCh)	BLE 4-BYTE ADDRESS MODE/EXIT 4-BYTE ADDRESS MODE commands.
4-BYTE QUAD OUTPUT FAST READ (6Ch)	Each address bit is latched in during the rising edge of the clock. The ad- dressed byte can be at any location, and the address automatically incre- ments to the next address after each byte of data is shifted out; there-
4-BYTE QUAD INPUT/OUTPUT FAST READ (ECh)	
DTR 4-BYTE FAST READ (0Eh)	fore, a die can be read with a single command. FAST READ can operate at a higher frequency ( <sup>f</sup> C).
DTR 4-BYTE DUAL INPUT/OUTPUT FAST READ (BEh)	4-BYTE commands and DTR 4-BYTE commands function in 4-BYTE and DTR 4-BYTE protocols regardless of settings in the nonvolatile configura-
DTR 4-BYTE QUAD INPUT/OUTPUT FAST READ (EEh)	tion register or enhanced volatile configuration register; other command function in 4-BYTE and DTR protocols only after the specific protocol is enabled by the register settings.

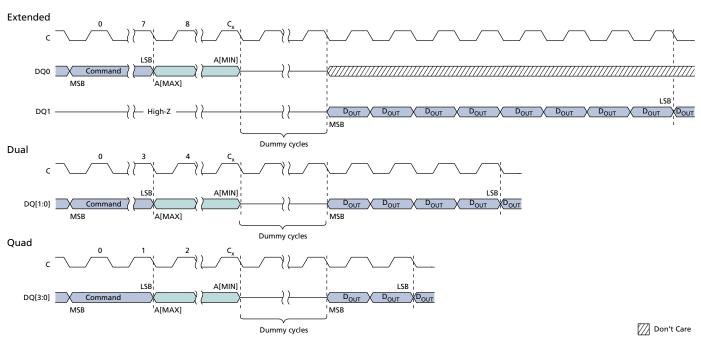


# **READ MEMORY Operations Timings**

#### Figure 18: READ - 03h/13h<sup>3</sup>



- Notes: 1. For extended protocol,  $C_x = 7 + (A[MAX] + 1)$ ; For dual protocol,  $C_x = 3 + (A[MAX] + 1)/2$ ; For quad protocol,  $C_x = 1 + (A[MAX] + 1)/4$ .
  - 2. S# not shown.
  - 3. READ and 4-BYTE READ commands.

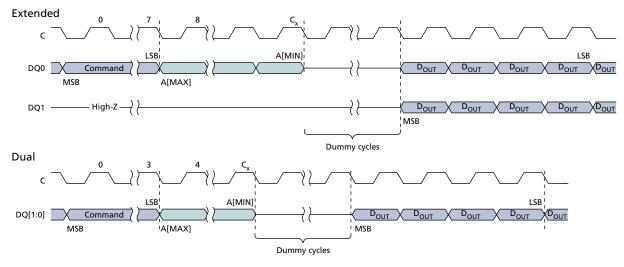


### Figure 19: FAST READ – 0Bh/0Ch<sup>3</sup>

- Notes: 1. For extended protocol,  $C_x = 7 + (A[MAX] + 1)$ ; For dual protocol,  $C_x = 3 + (A[MAX] + 1)/2$ ; For quad protocol,  $C_x = 1 + (A[MAX] + 1)/4$ .
  - 2. S# not shown.
  - 3. FAST READ and 4-BYTE FAST READ commands.

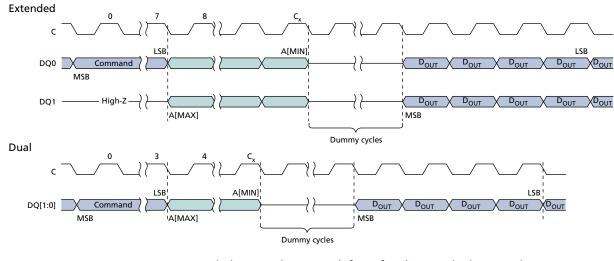


#### Figure 20: DUAL OUTPUT FAST READ – 3Bh/3Ch<sup>3</sup>



- Notes: 1. For extended protocol,  $C_x = 7 + (A[MAX] + 1)$ ; For dual protocol,  $C_x = 3 + (A[MAX] + 1)/2$ . 2. S# not shown.
  - 3. DUAL OUTPUT FAST READ and 4-BYTE DUAL OUTPUT FAST READ commands.

#### Figure 21: DUAL INPUT/OUTPUT FAST READ – BBh/BCh<sup>3</sup>

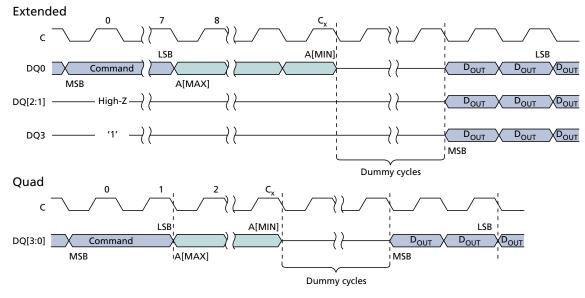


Notes: 1. For extended protocol,  $C_x = 7 + (A[MAX] + 1)/2$ ; For dual protocol,  $C_x = 3 + (A[MAX] + 1)/2$ .

- 2. S# not shown.
- 3. DUAL INPUT/OUTPUT FAST READ and 4-BYTE DUAL INPUT/OUTPUT FAST READ commands.

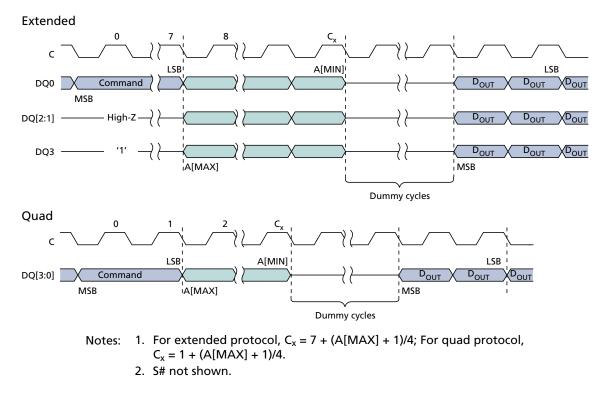


### Figure 22: QUAD OUTPUT FAST READ - 6Bh/6Ch<sup>3</sup>



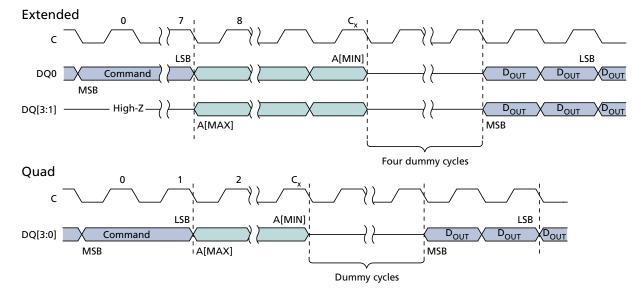
- Notes: 1. For extended protocol,  $C_x = 7 + (A[MAX] + 1)$ ; For quad protocol,  $C_x = 1 + (A[MAX] + 1)/4$ .
  - 2. S# not shown.
  - 3. QUAD OUTPUT FAST READ and 4-BYTE QUAD OUTPUT FAST READ commands.

### Figure 23: QUAD INPUT/OUTPUT FAST READ – EBh/ECh<sup>3</sup>





3. QUAD INPUT/OUTPUT FAST READ and 4-BYTE QUAD INPUT/OUTPUT FAST READ commands.



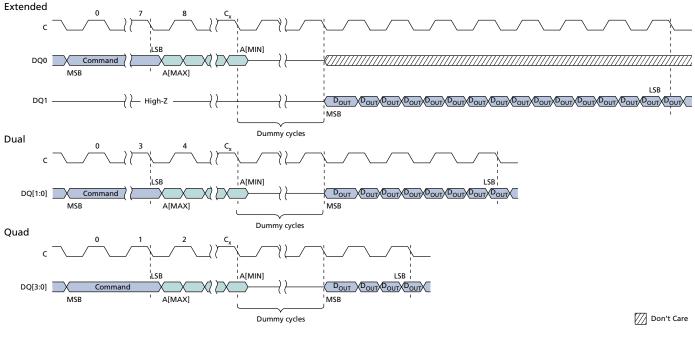
### Figure 24: QUAD INPUT/OUTPUT WORD READ - E7h<sup>3</sup>

- Notes: 1. For extended protocol,  $C_x = 7 + (A[MAX] + 1)/4$ ; For quad protocol,  $C_x = 1 + (A[MAX] + 1)/4$ .
  - 2. S# not shown.
  - 3. QUAD INPUT/OUTPUT WORD READ and 4-BYTE QUAD INPUT/OUTPUT WORD READ commands.



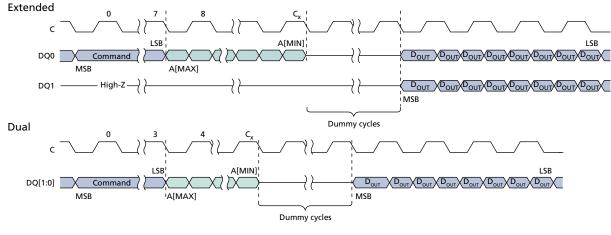
### 512Mb, 1.8V Multiple I/O Serial Flash Memory READ MEMORY Operations Timings

#### Figure 25: DTR FAST READ – 0Dh/0Eh<sup>3</sup>



- Notes: 1. For extended protocol,  $C_x = 7 + (A[MAX] + 1)/2$ ; For dual protocol,  $C_x = 3 + (A[MAX] + 1)/4$ ; For quad protocol,  $C_x = 1 + (A[MAX] + 1)/8$ .
  - 2. S# not shown.
  - 3. DTR FAST READ and 4-BYTE DTR FAST READ commands.

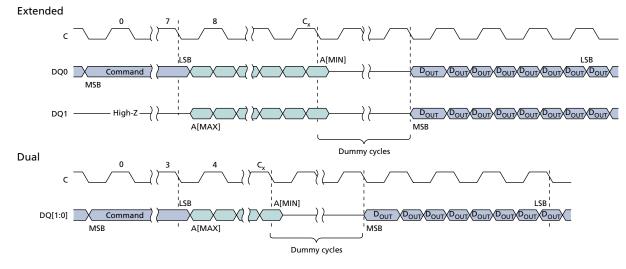
#### Figure 26: DTR DUAL OUTPUT FAST READ - 3Dh<sup>3</sup>



- Notes: 1. For extended protocol,  $C_x = 7 + (A[MAX] + 1)/2$ ; For dual protocol,  $C_x = 3 + (A[MAX] + 1)/4$ .
  - 2. S# not shown.
  - 3. DTR DUAL OUTPUT FAST READ and 4-BYTE DTR DUAL OUTPUT FAST READ commands.



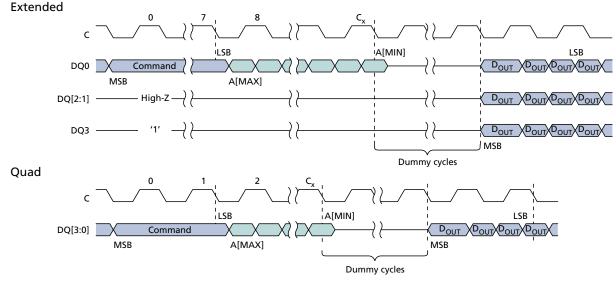
### Figure 27: DTR DUAL INPUT/OUTPUT FAST READ – BDh<sup>3</sup>



- Notes: 1. For extended protocol,  $C_x = 7 + (A[MAX] + 1)/4$ ; For dual protocol,  $C_x = 3 + (A[MAX] + 1)/8$ .
  - 2. S# not shown.
  - 3. DTR DUAL INPUT/OUTPUT FAST READ and 4-BYTE DTR DUAL INPUT/OUTPUT FAST READ commands.

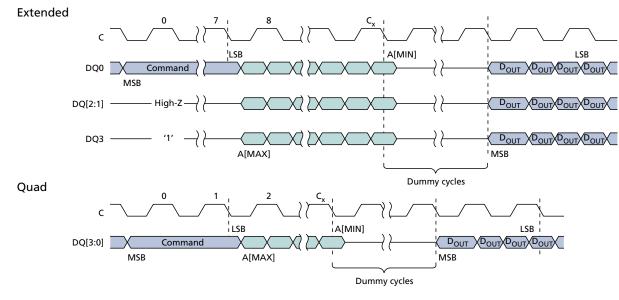


### Figure 28: DTR QUAD OUTPUT FAST READ - 6Dh<sup>3</sup>



- Notes: 1. For extended protocol,  $C_x = 7 + (A[MAX] + 1)/2$ ; For quad protocol,  $C_x = 1 + (A[MAX] + 1)/8$ .
  - 2. S# not shown.
  - 3. DTR QUAD OUTPUT FAST READ and 4-BYTE DTR QUAD OUTPUT FAST READ commands.

#### Figure 29: DTR QUAD INPUT/OUTPUT FAST READ - EDh<sup>3</sup>



- Notes: 1. For extended protocol,  $C_x = 7 + (A[MAX] + 1)/8$ ; For quad protocol,  $C_x = 1 + (A[MAX] + 1)/8$ .
  - 2. S# not shown.
  - 3. DTR QUAD INPUT/OUTPUT FAST READ and 4-BYTE DTR QUAD INPUT/OUTPUT FAST READ commands.



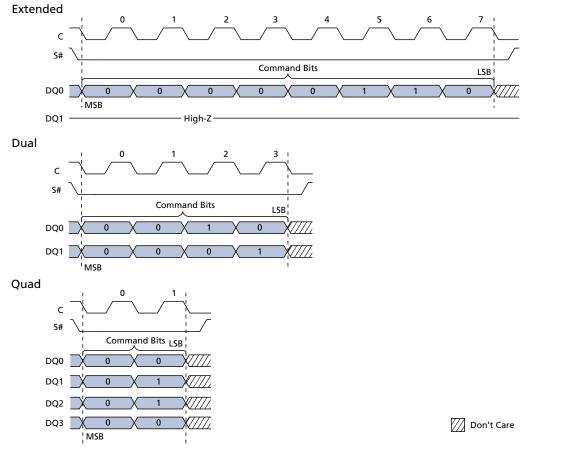
# **WRITE ENABLE/DISABLE Operations**

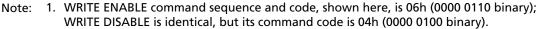
To initiate a command, S# is driven LOW and held LOW until the eighth bit of the command code has been latched in, after which it must be driven HIGH. For extended, dual, and quad SPI protocols respectively, the command code is input on DQ0, DQ[1:0], and DQ[3:0]. If S# is not driven HIGH after the command code has been latched in, the command is not executed, flag status register error bits are not set, and the write enable latch remains cleared to its default setting of 0, providing protection against errant data modification.

#### Table 26: WRITE ENABLE/DISABLE Operations

Operation Name	Description/Conditions	
WRITE ENABLE (06h)	Sets the write enable latch bit before each PROGRAM, ERASE, and WRITE command.	
	Clears the write enable latch bit. In case of a protection error, WRITE DISABLE will not clear the bit. Instead, a CLEAR FLAG STATUS REGISTER command must be issued to clear both flags.	

### Figure 30: WRITE ENABLE and WRITE DISABLE Timing





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# **READ REGISTER Operations**

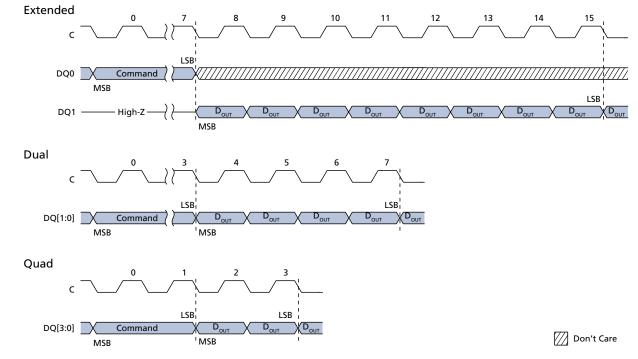
To initiate a command, S# is driven LOW. For extended SPI protocol, input is on DQ0, output on DQ1. For dual SPI protocol, input/output is on DQ[1:0] and for quad SPI protocol, input/output is on DQ[3:0]. The operation is terminated by driving S# HIGH at any time during data output.

### **Table 27: READ REGISTER Operations**

Operation Name	Description/Conditions	Note
READ STATUS REGISTER (05h)	Can be read continuously and at any time, including during a PRO-	
READ FLAG STATUS REGISTER (70h)	GRAM, ERASE, or WRITE operation. If one of these operations is in progress, checking the write in progress bit or P/E controller bit is recommended before executing the command.	
READ NONVOLATILE CONFIGURATION REGISTER (B5h)	Can be read continuously. After all 16 bits of the register have been read, a 0 is output. All reserved fields output a value of 1.	1
READ VOLATILE CONFIGURATION REGIS- TER (85h)	When the register is read continuously, the same byte is output repeatedly.	
READ ENHANCED VOLATILE CONFIGURA- TION REGISTER (65h)		
READ EXTENDED ADDRESS REGISTER (C8h)		

#### Note: 1. The operation will have output data starting from the least significant byte.

### Figure 31: READ REGISTER Timing







- 2. A READ NONVOLATILE CONFIGURATION REGISTER operation will output data starting from the least significant byte.
- 3. S# not shown.

# **WRITE REGISTER Operations**

Before a WRITE REGISTER command is initiated, the WRITE ENABLE command must be executed to set the write enable latch bit to 1. To initiate a command, S# is driven LOW and held LOW until the eighth bit of the last data byte has been latched in, after which it must be driven HIGH; for the WRITE NONVOLATILE CONFIGURATION REG-ISTER command, S# is held LOW until the 16th bit of the last data byte has been latched in. For the extended, dual, and quad SPI protocols respectively, input is on DQ0, DQ[1:0], and DQ[3:0], followed by the data bytes. If S# is not driven HIGH, the command is not executed, flag status register error bits are not set, and the write enable latch remains set to 1. The operation is self-timed and its duration is <sup>t</sup>W for WRITE STA-TUS REGISTER and <sup>t</sup>NVCR for WRITE NONVOLATILE CONFIGURATION REGISTER.

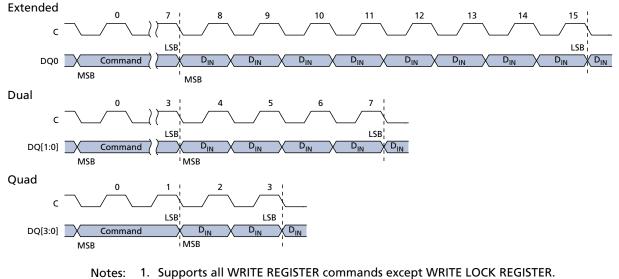
### **Table 28: WRITE REGISTER Operations**

Operation Name	Description/Conditions	Note
WRITE STATUS REGISTER (01h)	The WRITE STATUS REGISTER command writes new values to status register bits 7:2, enabling software data protection. The status register can also be combined with the W# signal to provide hardware data protection. This command has no effect on status register bits 1:0.	1
WRITE NONVOLATILE CONFIGURATION REGISTER (B1h)	For the WRITE STATUS REGISTER and WRITE NONVOLATILE CONFIG- URATION REGISTER commands, when the operation is in progress, the write in progress bit is set to 1. The write enable latch bit is cleared to 0, whether the operation is successful or not. The status register and flag status register can be polled for the operation sta- tus. When the operation completes, the write in progress bit is cleared to 0, whether the operation is successful or not.	
WRITE VOLATILE CONFIGURATION REGIS- TER (81h)	Because register bits are volatile, change to the bits is immediate. Reserved bits are not affected by this command.	
WRITE ENHANCED VOLATILE CONFIGURA- TION REGISTER (61h)		
WRITE EXTENDED ADDRESS REGISTER (C5h)		

Note: 1. The WRITE NONVOLATILE CONFIGURATION REGISTER operation must have input data starting from the least significant byte.



### Figure 32: WRITE REGISTER Timing



- 2. Data is two bytes for a WRITE NONVOLATILE CONFIGURATION REGISTER operation, input starting from the least significant byte.
- 3. S# not shown.



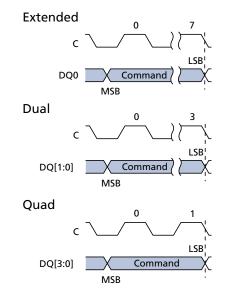
# **CLEAR FLAG STATUS REGISTER Operation**

To initiate a command, S# is driven LOW. For the extended, dual, and quad SPI protocols respectively, input is on DQ0, DQ[1:0], and DQ[3:0]. The operation is terminated by driving S# HIGH at any time.

### **Table 29: CLEAR FLAG STATUS REGISTER Operation**

Operation Name	Description/Conditions	
CLEAR FLAG STATUS REGISTER (50h)	Resets the error bits (erase, program, and protection)	

### Figure 33: CLEAR FLAG STATUS REGISTER Timing



Note: 1. S# not shown.



# **PROGRAM Operations**

Before a PROGRAM command is initiated, the WRITE ENABLE command must be executed to set the write enable latch bit to 1. To initiate a command, S# is driven LOW and held LOW until the eighth bit of the last data byte has been latched in, after which it must be driven HIGH. If S# is not driven HIGH, the command is not executed, flag status register error bits are not set, and the write enable latch remains set to 1. Each address bit is latched in during the rising edge of the clock. When a command is applied to a protected sector, the command is not executed, the write enable latch bit remains set to 1, and flag status register bits 1 and 4 are set. If the operation times out, the write enable latch bit is reset and the program fail bit is set to 1.

**Note:** The manner of latching data shown and explained in the timing diagrams ensures that the number of clock pulses is a multiple of one byte before command execution, helping reduce the effects of noisy or undesirable signals and enhancing device data protection.

#### **Table 30: PROGRAM Operations**

Operation Name	Description/Conditions
PAGE PROGRAM (02h)	A PROGRAM operation changes a bit from 1 to 0.
DUAL INPUT FAST PROGRAM (A2h)	When the operation is in progress, the write in progress bit is set to 1.
EXTENDED DUAL INPUT FAST PROGRAM (D2h)	The write enable latch bit is cleared to 0, whether the operation is suc-
QUAD INPUT FAST PROGRAM (32h)	cessful or not. The status register and flag status register can be polled for the operation status. When the operation completes, the write in progress bit is cleared to 0. An operation can be paused or resumed by the PROGRAM/ERASE SUSPEND or PROGRAM/ERASE RESUME command respectively. If the bits of the least significant address, which is the starting address, are not all zero, all data transmitted beyond the end of the current page is programmed from the starting address of the same page. If the number of bytes sent to the device exceed the maximum page size, pre- viously latched data is discarded and only the last maximum page-size number of data bytes are guaranteed to be programmed correctly with in the same page. If the number of bytes sent to the device is less than the maximum page size, they are correctly programmed at the specified addresses without any effect on the other bytes of the same page.
EXTENDED QUAD INPUT FAST PROGRAM (38h)	

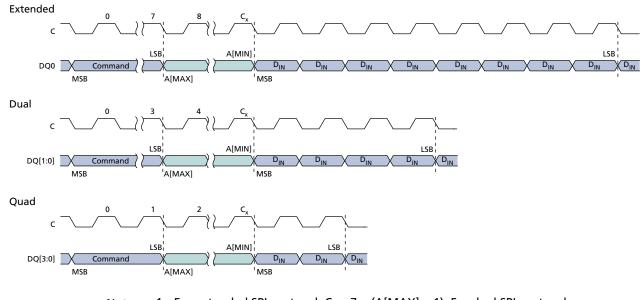


# **4-BYTE PROGRAM Operations**

### Table 31: 4-BYTE PROGRAM Operations

Operation Name	Description/Conditions
4-BYTE PAGE PROGRAM (12h)	PROGRAM operations can be extended to a 4-byte address range, with
4-BYTE QUAD INPUT FAST PROGRAM (34h)	[A31:0] input during address cycle.
4-BYTE EXTENDED QUAD INPUT FAST PRO- GRAM (3Eh)	Selection of the 3-byte or 4-byte address range can be enabled in two ways: through the nonvolatile configuration register or through the ABLE 4-BYTE ADDRESS MODE/EXIT 4-BYTE ADDRESS MODE command 4-BYTE commands and DTR 4-BYTE commands function in 4-BYTE an DTR 4-BYTE protocol regardless of settings in the nonvolatile configu- tion register or enhanced volatile configuration register; other com- mands function in 4-BYTE and DTR protocols only after the specific p tocol is enabled by the register settings.

# **PROGRAM Operations Timings**

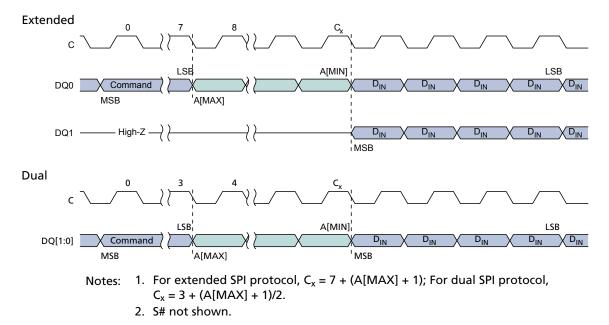


### Figure 34: PAGE PROGRAM Command

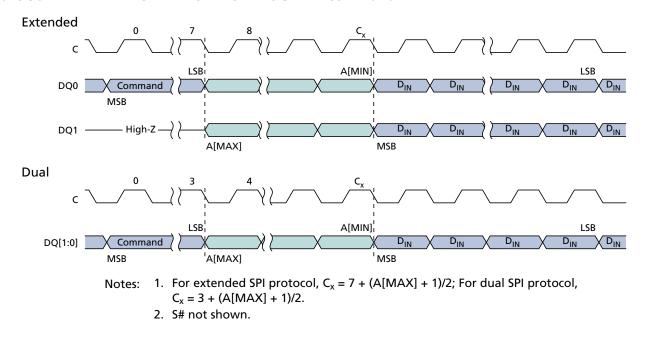
Notes: 1. For extended SPI protocol, C<sub>x</sub> = 7 + (A[MAX] + 1); For dual SPI protocol, C<sub>x</sub> = 3 + (A[MAX] + 1)/2; For quad SPI protocol, C<sub>x</sub> = 1 + (A[MAX] + 1)/4.
2. S# not shown. The operation is self-timed, and its duration is <sup>t</sup>PP.



#### Figure 35: DUAL INPUT FAST PROGRAM Command

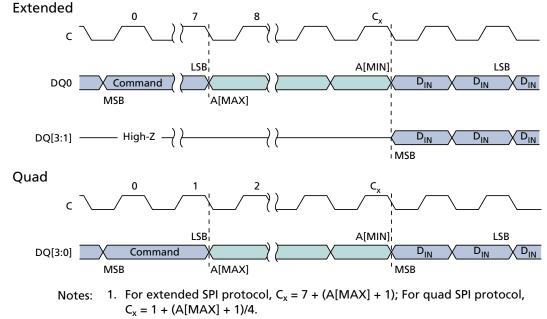


### Figure 36: EXTENDED DUAL INPUT FAST PROGRAM Command



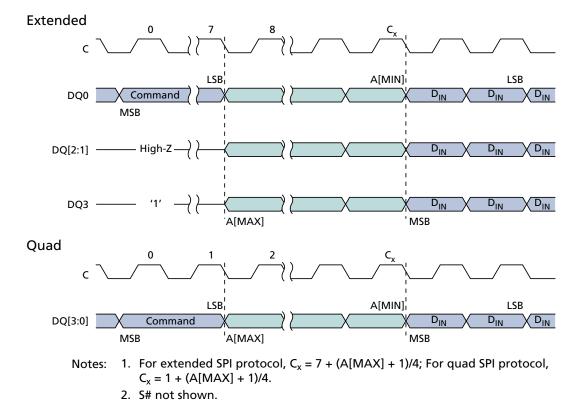


#### Figure 37: QUAD INPUT FAST PROGRAM Command



2. S# not shown.

### Figure 38: EXTENDED QUAD INPUT FAST PROGRAM Command





# **ERASE Operations**

An ERASE operation changes a bit from 0 to 1. Before any ERASE command is initiated, the WRITE ENABLE command must be executed to set the write enable latch bit to 1; if not, the device ignores the command and no error bits are set to indicate operation failure. S# is driven LOW and held LOW until the eighth bit of the last data byte has been latched in, after which it must be driven HIGH. The operations are self-timed, and duration is <sup>t</sup>SSE, <sup>t</sup>SE, or <sup>t</sup>BE according to command.

If S# is not driven HIGH, the command is not executed, flag status register error bits are not set, and the write enable latch remains set to 1. A command applied to a protected subsector is not executed. Instead, the write enable latch bit remains set to 1, and flag status register bits 1 and 5 are set.

When the operation is in progress, the program or erase controller bit of the flag status register is set to 0. In addition, the write in progress bit is set to 1. When the operation completes, the write in progress bit is cleared to 0. The write enable latch bit is cleared to 0, whether the operation is successful or not. If the operation times out, the write enable latch bit is reset and the erase error bit is set to 1.

The status register and flag status register can be polled for the operation status. When the operation completes, these register bits are cleared to 1.

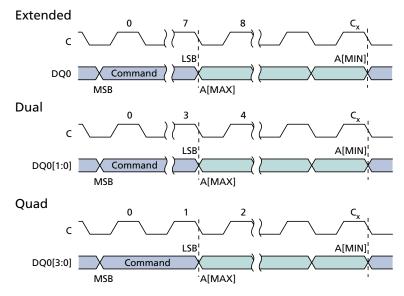
**Note:** For all ERASE operations, noisy or undesirable signal effects can be reduced and device data protection enhanced by holding S# LOW until the eighth bit of the last data byte has been latched in; this ensures that the number of clock pulses is a multiple of one byte before command execution.

Operation Name	Description/Conditions	
SUBSECTOR ERASE (52h/20h)	Sets the selected subsector or sector bits to FFh. Any address within the subsector is valid for entry. Each address bit is latched in during the rising edge of the clock. The operation can be suspended and resumed by the PROGRAM/ERASE SUSPEND and PROGRAM/ERASE RESUME commands, respectively.	
SECTOR ERASE (D8h)		
BULK ERASE (C7h/60h)	Sets the device bits to FFh. The command is not executed if any sector is locked. Instead, the write enable latch bit remains set to 1, and flag status register bits 1 and 5 are set.	

### **Table 32: ERASE Operations**

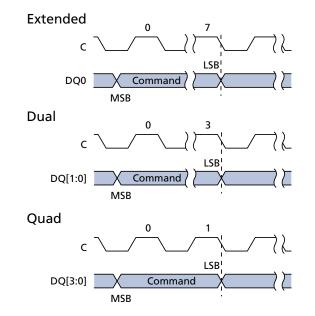


### Figure 39: SUBSECTOR and SECTOR ERASE Timing



- Notes: 1. For extended SPI protocol, C<sub>x</sub> = 7 + (A[MAX] + 1); For dual SPI protocol, C<sub>x</sub> = 3 + (A[MAX] + 1)/2; For quad SPI protocol, C<sub>x</sub> = 1 + (A[MAX] + 1)/4.
  2. S# not shown.
  - 2. S# not show

### Figure 40: BULK ERASE Timing



Note: 1. S# not shown.



# **SUSPEND/RESUME Operations**

## **PROGRAM/ERASE SUSPEND Operations**

A PROGRAM/ERASE SUSPEND command enables the memory controller to interrupt and suspend an array PROGRAM or ERASE operation within the program/erase latency. To initiate the command, S# is driven LOW, and the command code is input on DQn. The operation is terminated by the PROGRAM/ERASE RESUME command.

For a PROGRAM SUSPEND, the flag status register bit 2 is set to 1. For an ERASE SUS-PEND, the flag status register bit 6 is set to 1.

After an erase/program latency time, the flag status register bit 7 is also set to 1, but the device is considered in suspended state once bit 7 of the flag status register outputs 1 with at least one byte output. In the suspended state, the device is waiting for any operation.

If the time remaining to complete the operation is less than the suspend latency, the device completes the operation and clears the flag status register bits 2 or 6, as applicable. Because the suspend state is volatile, if there is a power cycle, the suspend state information is lost and the flag status register powers up as 80h.

It is possible to nest a PROGRAM/ERASE SUSPEND operation inside a PROGRAM/ ERASE SUSPEND operation just once. Issue an ERASE command and suspend it. Then issue a PROGRAM command and suspend it also. With the two operations suspended, the next PROGRAM/ERASE RESUME command resumes the latter operation, and a second PROGRAM/ERASE RESUME command resumes the former (or first) operation.

### **PROGRAM/ERASE RESUME Operations**

A PROGRAM/ERASE RESUME operation terminates the PROGRAM/ERASE RESUME command. To initiate the command, S# is driven LOW, and the command code is input on DQn. The operation is terminated by driving S# HIGH.

Operation Name	Description/Conditions	
PROGRAM SUSPEND (75h)	A READ operation is possible in any page except the one in a suspended state. Reading from a sector that is in a suspended state will output indeterminate data.	
ERASE SUSPEND (75h)	A PROGRAM or READ operation is possible in any sector except the one in a suspended state. Reading from a sector that is in a suspended state will output indeterminate data. During a SUSPEND SUBSECTOR ERASE operation, reading an address in the sector that contains the suspended subsector could output indeterminate data. The device ignores a PROGRAM command to a sector that is in an erase suspend state; it also sets the flag status register bit 4 to 1 (program failure/protection error) and leaves the write enable latch bit unchanged. When the ERASE resumes, it does not check the new lock status of the WRITE VOLATILE LOCK BITS command.	

### **Table 33: SUSPEND/RESUME Operations**

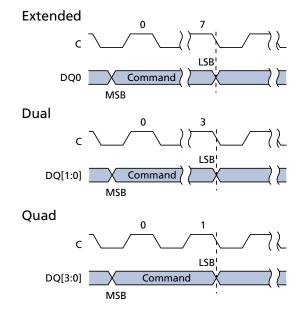


### Table 33: SUSPEND/RESUME Operations (Continued)

Operation Name	Description/Conditions
PROGRAM RESUME (7Ah)	The status register write in progress bit is set to 1 and the flag status register program
ERASE RESUME (7Ah)	erase controller bit is set to 0. The command is ignored if the device is not in a suspen- ded state. When the operation is in progress, the program or erase controller bit of the flag status register is set to 0. The flag status register can be polled for the operation status. When the operation completes, that bit is cleared to 1.

Note: 1. See the Operations Allowed/Disallowed During Device States table.

#### Figure 41: PROGRAM/ERASE SUSPEND and RESUME Timing



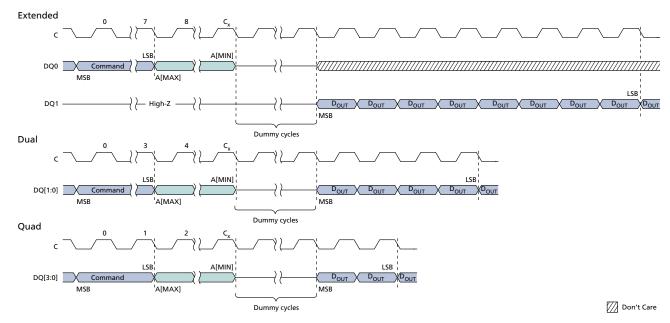
Note: 1. S# not shown.



# **ONE-TIME PROGRAMMABLE Operations**

## **READ OTP ARRAY Command**

To initiate a READ OTP ARRAY command, S# is driven LOW. The command code is input on DQ0, followed by address bytes and dummy clock cycles. Each address bit is latched in during the rising edge of C. Data is shifted out on DQ1, beginning from the specified address and at a maximum frequency of <sup>f</sup>C (MAX) on the falling edge of the clock. The address increments automatically to the next address after each byte of data is shifted out. There is no rollover mechanism; therefore, if read continuously, after location 0x40, the device continues to output data at location 0x40. The operation is terminated by driving S# HIGH at any time during data output.



#### Figure 42: READ OTP Command Timing

Note: 1. For extended SPI protocol,  $C_x = 7 + (A[MAX] + 1)$ ; For dual SPI protocol,  $C_x = 3 + (A[MAX] + 1)/2$ ; For quad SPI protocol,  $C_x = 1 + (A[MAX] + 1)/4$ .

## **PROGRAM OTP ARRAY Command**

To initiate the PROGRAM OTP ARRAY command, the WRITE ENABLE command must be issued to set the write enable latch bit to 1; otherwise, the PROGRAM OTP ARRAY command is ignored and flag status register bits are not set. S# is driven LOW and held LOW until the eighth bit of the last data byte has been latched in, after which it must be driven HIGH. The command code is input on DQ0, followed by address bytes and at least one data byte. Each address bit is latched in during the rising edge of the clock. When S# is driven HIGH, the operation, which is self-timed, is initiated; its duration is <sup>t</sup>POTP. There is no rollover mechanism; therefore, after a maximum of 65 bytes are latched in the subsequent bytes are discarded.

PROGRAM OTP ARRAY programs, at most, 64 bytes to the OTP memory area and one OTP control byte. When the operation is in progress, the write in progress bit is set to 1.



### 512Mb, 1.8V Multiple I/O Serial Flash Memory ONE-TIME PROGRAMMABLE Operations

The write enable latch bit is cleared to 0, whether the operation is successful or not, and the status register and flag status register can be polled for the operation status. When the operation completes, the write in progress bit is cleared to 0.

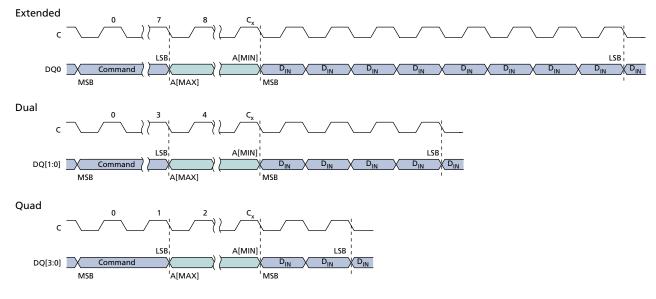
If the operation times out, the write enable latch bit is reset and the program fail bit is set to 1. If S# is not driven HIGH, the command is not executed, flag status register error bits are not set, and the write enable latch remains set to 1. The operation is considered complete once bit 7 of the flag status register outputs 1 with at least one byte output.

The OTP control byte (byte 64) is used to permanently lock the OTP memory array.

### Table 34: OTP Control Byte (Byte 64)

Bit	Name	Settings	Description
0	OTP control byte	0 = Locked 1 = Unlocked (default)	Used to permanently lock the 64-byte OTP array. When bit 0 = 1, the 64-byte OTP array can be programmed. When bit 0 = 0, the 64-byte OTP array is read only. Once bit 0 has been programmed to 0, it can no longer be changed to 1. Program OTP array is ignored, the write enable latch bit remains set, and flag status register bits 1 and 4 are set.

### Figure 43: PROGRAM OTP Command Timing



Note: 1. For extended SPI protocol,  $C_x = 7 + (A[MAX] + 1)$ ; For dual SPI protocol,  $C_x = 3 + (A[MAX] + 1)/2$ ; For quad SPI protocol,  $C_x = 1 + (A[MAX] + 1)/4$ .



## **ADDRESS MODE Operations**

### **ENTER and EXIT 4-BYTE ADDRESS MODE Command**

To initiate these commands, S# is driven LOW, and the command is input on DQn.

### Table 35: ENTER and EXIT 4-BYTE ADDRESS MODE Operations

Operation Name	Description/Conditions
ENTER 4-BYTE ADDRESS MODE (B7h)	The effect of the command is immediate. The default address mode is three bytes,
EXIT 4-BYTE ADDRESS MODE (E9h)	and the device returns to the default upon exiting the 4-byte address mode.



## **DEEP POWER-DOWN Operations**

### **ENTER DEEP POWER-DOWN Command**

To execute ENTER DEEP POWER-DOWN, S# must be driven high after the eighth bit of the command code is latched in, after which, tDP time must elapse before the supply current is reduced to  $I_{CC2.}$  Any attempt to execute ENTER DEEP POWER-DOWN during a WRITE operation is rejected without affecting the operation.

In deep power-down mode, no device error bits are set, the WEL state is unchanged, and the device ignores all commands except RELEASE FROM DEEP POWER-DOWN, RESET ENABLE, RESET, hardware reset, and power-loss rescue sequence commands.

### **RELEASE FROM DEEP POWER-DOWN Command**

To execute the RELEASE FROM DEEP POWER-DOWN command, S# is driven low, followed by the command code. Sending additional clock cycles on C, while S# is driven low voids the command.

RELEASE FROM DEEP POWER-DOWN is terminated by driving S# high. The device enters standby mode after S# is driven high followed by a delay of tRDP. S# must remain high during this time.

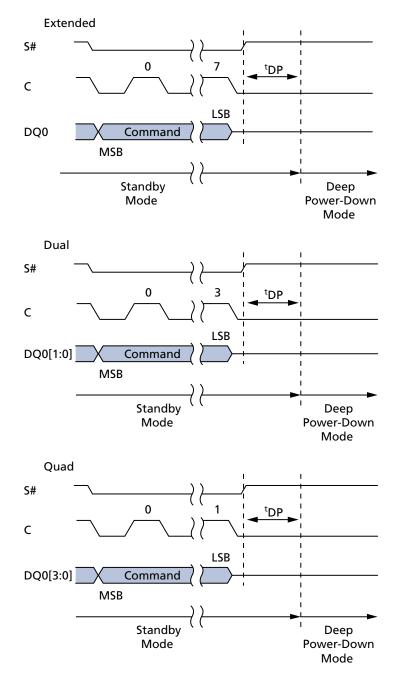
Operation Name	Description/Conditions
ENTER DEEP POWER-DOWN (B9h)	The command is used to place the device in deep power-down mode for the lowest device power consumption, with device current reduced to I <sub>CC2.</sub> This command can also be used as a software protection mechanism while the device is not in active use.
RELEASE FROM DEEP POWER-DOWN (ABh)	The command is used to exit from deep power-down mode. The device also exits deep power-down mode upon:
	A power-down, entering standby mode with the next power-up;
	A hardware or software reset operation, entering standby mode with a recovery time as specified in the AC Reset Specifications.

#### **Table 36: DEEP POWER-DOWN Operations**



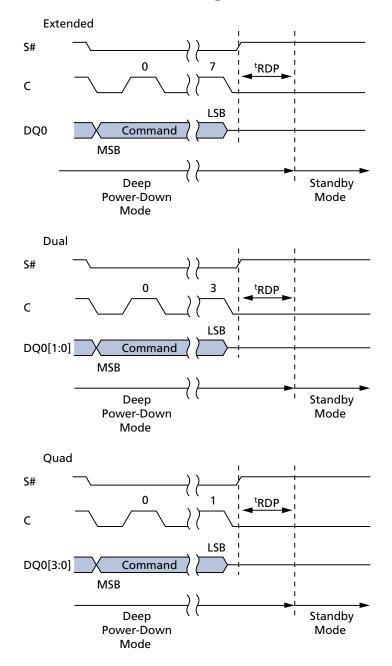
### **DEEP POWER-DOWN Timings**

### Figure 44: ENTER DEEP POWER-DOWN Timing





#### Figure 45: RELEASE FROM DEEP POWER-DOWN Timing





## **QUAD PROTOCOL Operations**

## **ENTER or RESET QUAD INPUT/OUTPUT MODE Command**

To initiate these commands, the WRITE ENABLE command must not be executed. S# must be driven LOW, and the command must be input on DQ*n*.

#### Table 37: ENTER and RESET QUAD PROTOCOL Operations

Operation Name	Description/Conditions
ENTER QUAD INPUT/OUTPUT MODE (35h)	The effect of the command is immediate.
RESET QUAD INPUT/OUTPUT MODE (F5h)	



## **CYCLIC REDUNDANCY CHECK Operations**

A CYCLIC REDUNDANCY CHECK (CRC) operation is a hash function designed to detect accidental changes to raw data and is used commonly in digital networks and storage devices such as hard disk drives. A CRC-enabled device calculates a short, fixedlength binary sequence, known as the CRC code or just CRC, for each block of data. CRC can be a higher performance alternative to reading data directly in order to verify recently programmed data. Or, it can be used to check periodically the data integrity of a large block of data against a stored CRC reference over the life of the product. CRC helps improve test efficiency for programmer or burn-in stress tests. No system hardware changes are required to enable CRC.

The CRC-64 operation follows the ECMA standard. The generating polynomial is:

 $G(x) = x^{64} + x^{62} + x^{57} + x^{55} + x^{54} + x^{53} + x^{52} + x^{47} + x^{46} + x^{45} + x^{40} + x^{39} + x^{38} + x^{37} + x^{35} + x^{33}$ 

 $+ x^{32} + x^{31} + x^{29} + x^{27} + x^{24} + x^{23} + x^{22} + x^{21} + x^{19} + x^{17} + x^{13} + x^{12} + x^{10} + x^9 + x^7 + x^4 + x + 1$ 

Note: The data stream sequence is from LSB to MSB and the default initial CRC value is all zero.

The device CRC operation generates the CRC result of the entire device or of an address range specified by the operation. Then the CRC result is compared with the expected CRC data provided in the sequence. Finally the device indicates a pass or fail through the bit #4 of FLAG STATUS REGISTER. If the CRC fails, it is possible to take corrective action such as verifying with a normal read mode or by rewriting the array data.

CRC operation supports CRC data read back when CRC check fails; the CRC data generated from the target address range or entire device will be stored in a dedicated register: general purpose read register (GPRR) only when CRC check fails, and it can be read out through the GPRR read sequence with command 96h, least significant byte first. GPRR is reset to default all 0 at the beginning of the CRC operation, and so customer will read all 0 if CRC operation pass.

Note that the GPRR is a volatile register. It is cleared to all 0s on power-up and hard-ware/software reset. Read GPRR starts from the first location, when clocked continuously, will output 00h after location 64.

The CYCLIC REDUNDANCY CHECK operation command sequences are shown in the tables below, for an entire die or for a selected range.

#### **Table 38: CRC Command Sequence on Entire Device**

Comma	nd Sequence		
Byte# Data		Description	
1	9Bh	Command code for interface activation	
2	27h	Sub-command code for CRC operation	
3	FFh	CRC operation option selection (CRC operation on entire device)	
4	CRC[7:0]	1st byte of expected CRC value	
5–10	CRC[55:8]	2nd to 7th byte of expected CRC value	
11	CRC[63:56]	8th byte of expected CRC value	
Drive S# HIGH		Operation sequence confirmed; CRC operation starts	

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### 512Mb, 1.8V Multiple I/O Serial Flash Memory CYCLIC REDUNDANCY CHECK Operations

### Table 39: CRC Command Sequence on a Range

Command Sequence			
Byte#	Data	Description	
1	9Bh	Command code for interface activation	
2	27h	Sub-command code for CRC operation	
3	FEh	CRC operation option selection (CRC operation on a range)	
4	CRC[7:0]	1st byte of expected CRC value	
5–10	CRC[55:8]	2nd to 7th byte of expected CRC value	
11	CRC[63:56]	8th byte of expected CRC value	
12	Start Address [7:0]	Specifies the starting byte address for CRC operation	
13–14	Start Address [23:8]		
15	Start Address [31:24]		
16	Stop Address [7:0]	Specifies the ending byte address for CRC operation	
17–18	Stop Address [23:8]		
19	Stop Address [31:24]		
Drive	e S# HIGH	Operation sequence confirmed; CRC operation starts	



## **State Table**

The device can be in only one state at a time. Depending on the state of the device, some operations as shown in the table below are allowed (Yes) and others are not (No). For example, when the device is in the standby state, all operations except SUSPEND are allowed in any sector. For all device states except the erase suspend state, if an operation is allowed or disallowed in one sector, it is allowed or disallowed in all other sectors. In the erase suspend state, a PROGRAM operation is allowed in any sector except the one in which an ERASE operation has been suspended.

### Table 40: Operations Allowed/Disallowed During Device States

Operation	Standby State	Program or Erase State	Subsector Erase Suspend or Program Suspend State	Erase Suspend State	Notes
READ (memory)	Yes	No	Yes	Yes	1
READ (status/flag status registers)	Yes	Yes	Yes	Yes	6
PROGRAM	Yes	No	No	Yes/No	2
ERASE (sector/subsector)	Yes	No	No	No	3
WRITE	Yes	No	No	No	4
WRITE	Yes	No	Yes	Yes	5
SUSPEND	No	Yes	No	No	7

- Notes: 1. All READ operations except READ STATUS REGISTER and READ FLAG REGISTER. When issued to a sector or subsector that is simultaneously in an erase suspend state, the READ operation is accepted, but the data output is not guaranteed until the erase has completed.
  - 2. All PROGRAM operations except PROGRAM OTP. In the erase suspend state, a PROGRAM operation is allowed in any sector (Yes) except the sector (No) in which an ERASE operation has been suspended.
  - 3. Applies to the SECTOR ERASE or SUBSECTOR ERASE operation.
  - 4. Applies to the following operations: WRITE STATUS REGISTER, WRITE NONVOLATILE CONFIGURATION REGISTER, PROGRAM OTP, and BULK ERASE.
  - 5. Applies to the WRITE VOLATILE CONFIGURATION REGISTER, WRITE ENHANCED VOLA-TILE CONFIGURATION REGISTER, WRITE ENABLE, WRITE DISABLE, CLEAR FLAG STATUS REGISTER, WRITE EXTENDED ADDRESS REGISTER, or WRITE LOCK REGISTER operation.
  - 6. Applies to the READ STATUS REGISTER or READ FLAG STATUS REGISTER operation.
  - 7. Applies to the PROGRAM SUSPEND or ERASE SUSPEND operation.



## **XIP Mode**

Execute-in-place (XIP) mode allows the memory to be read by sending an address to the device and then receiving the data on one, two, or four pins in parallel, depending on the customer requirements. XIP mode offers maximum flexibility to the application, saves instruction overhead, and reduces random access time.

### Activate and Terminate XIP Using Volatile Configuration Register

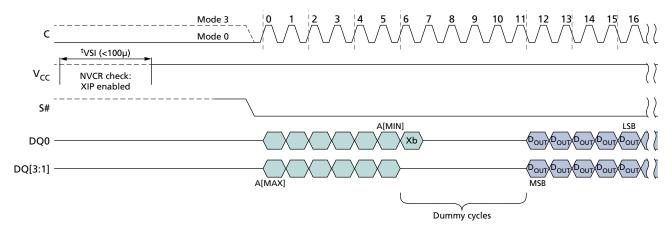
Applications that boot in SPI and must switch to XIP use the volatile configuration register. XIP provides faster memory READ operations by requiring only an address to execute, rather than a command code and an address.

To activate XIP requires two steps. First, enable XIP by setting volatile configuration register bit 3 to 0. Next, drive the XIP confirmation bit to 0 during the next FAST READ operation. XIP is then active. Once in XIP, any command that occurs after S# is toggled requires only address bits to execute; a command code is not necessary, and device operations use the SPI protocol that is enabled. XIP is terminated by driving the XIP confirmation bit to 1. The device automatically resets volatile configuration register bit 3 to 1.

**Note:** For devices with basic XIP, indicated by a part number feature set digit of 2 or 4, it is not necessary to set the volatile configuration register bit 3 to 0 to enable XIP. Instead, it is enabled by setting the XIP confirmation bit to 0 during the first dummy clock cycle after any FAST READ command.

### Activate and Terminate XIP Using Nonvolatile Configuration Register

Applications that must boot directly in XIP use the nonvolatile configuration register. To enable a device to power-up in XIP using this register, set nonvolatile configuration register bits [11:9]. Settings vary according to protocol, as explained in the Nonvolatile Configuration Register section. Because the device boots directly in XIP, after the power cycle, no command code is necessary. XIP is terminated by driving the XIP confirmation bit to 1.



### Figure 46: XIP Mode Directly After Power-On

Note: 1. Xb is the XIP confirmation bit and should be set as follows: 0 to keep XIP state; 1 to exit XIP mode and return to standard read mode.

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### **Confirmation Bit Settings Required to Activate or Terminate XIP**

The XIP confirmation bit setting activates or terminates XIP after it has been enabled or disabled. This bit is the value on DQ0 during the first dummy clock cycle in the FAST READ operation. In dual I/O XIP mode, the value of DQ1 during the first dummy clock cycle after the addresses is always "Don't Care." In quad I/O XIP mode, the values of DQ3, DQ2, and DQ1 during the first dummy clock cycle after the addresses are always "Don't Care."

#### **Table 41: XIP Confirmation Bit**

Bit Value	Description			
0	Activates XIP: While this bit is 0, XIP remains activated.			
1	Terminates XIP: When this bit is set to 1, XIP is terminated and the device returns to SPI.			

### Table 42: Effects of Running XIP in Different Protocols

Protocol	Effect
Extended I/O and Dual I/O	In a device with a dedicated part number where RST# is enabled, a LOW pulse on that pin resets XIP and the device to the state it was in previous to the last power-up, as defined by the nonvolatile configuration register.
Dual I/O	Values of DQ1 during the first dummy clock cycle are "Don't Care."
Quad I/O <sup>1</sup>	Values of DQ[3:1] during the first dummy clock cycle are "Don't Care." In a device with a dedica- ted part number, it is only possible to reset memory when the device is deselected.

Note: 1. In a device with a dedicated part number where RST# is enabled, a LOW pulse on that pin resets XIP and the device to the state it was in previous to the last power-up, as defined by the nonvolatile configuration register only when the device is deselected.

### **Terminating XIP After a Controller and Memory Reset**

The system controller and the device can become out of synchronization if, during the life of the application, the system controller is reset without the device being reset. In such a case, the controller can reset the memory to power-on reset if the memory has reset functionality. (Reset is available in devices with a dedicated part number.)

- 7 clock cycles within S# LOW (S# becomes HIGH before 8th clock cycle)
- + 9 clock cycles within S# LOW (S# becomes HIGH before 10th clock cycle)
- + 13 clock cycles within S# LOW (S# becomes HIGH before 14th clock cycle)
- + 17 clock cycles within S# LOW (S# becomes HIGH before 18th clock cycle)
- + 25 clock cycles within S# LOW (S# becomes HIGH before 26th clock cycle)
- + 33 clock cycles within S# LOW (S# becomes HIGH before 34th clock cycle)

These sequences cause the controller to set the XIP confirmation bit to 1, thereby terminating XIP. However, it does not reset the device or interrupt PROGRAM/ERASE operations that may be in progress. After terminating XIP, the controller must execute RESET ENABLE and RESET MEMORY to implement a software reset and reset the device.



## **Power-Up and Power-Down**

### **Power-Up and Power-Down Requirements**

At power-up and power-down, the device must not be selected; that is, S# must follow the voltage applied on  $V_{CC}$  until  $V_{CC}$  reaches the correct values:  $V_{CC,min}$  at power-up and  $V_{SS}$  at power-down.

To provide device protection and prevent data corruption and inadvertent WRITE operations during power-up, a power-on reset circuit is included. The logic inside the device is held to RESET while  $V_{CC}$  is less than the power-on reset threshold voltage shown here; all operations are disabled, and the device does not respond to any instruction. During a standard power-up phase, the device ignores all commands except READ STATUS REGISTER and READ FLAG STATUS REGISTER. These operations can be used to check the memory internal state. After power-up, the device is in standby power mode; the write enable latch bit is reset; the write in progress bit is reset; and the dynamic protection register is configured as: (write lock bit, lock down bit) = (0,0).

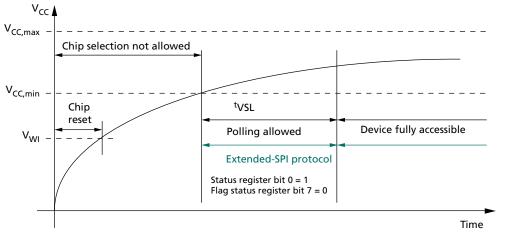
Normal precautions must be taken for supply line decoupling to stabilize the  $V_{CC}$  supply. Each device in a system should have the  $V_{CC}$  line decoupled by a suitable capacitor (typically 100nF) close to the package pins. At power-down, when  $V_{CC}$  drops from the operating voltage to below the power-on-reset threshold voltage shown here, all operations are disabled and the device does not respond to any command.

When the operation is in progress, the program or erase controller bit of the status register is set to 0. To obtain the operation status, the flag status register must be polled. When the operation completes, the program or erase controller bit is cleared to 1. The cycle is complete after the flag status register outputs the program or erase controller bit to 1.

**Note:** If power-down occurs while a WRITE, PROGRAM, or ERASE cycle is in progress, data corruption may result.



#### Figure 47: Power-Up Timing



Notes: 1. <sup>t</sup>VSL polling has to be in Extended-SPI protocol and STR mode.

- 2. During <sup>t</sup>VSL period, HOLD# is enabled, RESET# disabled, and output strength is in default setting.
- 3. In a system that uses a fast  $V_{CC}$  ramp rate, current design requires a minimum 100µs after  $V_{CC}$  reaches <sup>t</sup>VWI, and before the polling is allowed, even though  $V_{CC,min}$  is achieved.
- 4. In extended SPI protocol, the 1Gb/2Gb device must wait 100us after V<sub>CC</sub> reaches V<sub>CC,min</sub> before polling the status register or flag status register.

### Table 43: Power-Up Timing and V<sub>WI</sub> Threshold

Note 1 applies to entire table

Symbol	Parameter	Тур	Max	Unit	Notes
tVSL	V <sub>CC,min</sub> to device fully accessible	-	300	μs	2, 3
V <sub>WI</sub>	Write inhibit voltage	1.0	1.5	V	2

- Notes: 1. When  $V_{CC}$  reaches  $V_{CC,min}$ , to determine whether power-up initialization is complete, the host can poll status register bit 0 or flag status register bit 7 only in extended SPI protocol because the device will accept commands only on DQ0 and output data only on DQ1. When the device is ready, the host has full access using the protocol configured in the nonvolatile configuration register. If the host cannot poll the status register in x1 SPI mode, it is recommended to wait <sup>t</sup>VSL before accessing the device.
  - 2. Parameters listed are characterized only.
  - 3. On the first power up after an event causing a sub-sector erase operation interrupt (e.g. due to power-loss), the maximum time for tVSL will be up to 4.5ms in case of 4KB subsector erase interrupt and up to 36ms in case of 32KB sub-sector erase interrupt; this accounts for erase recovery embedded operation.



## Active, Standby, and Deep Power-Down Modes

When S# is low, the device is selected and in active power mode. When S# is high, the device is deselected but could remain in active power mode until ongoing internal operations are completed. Then the device goes into standby power mode and device current consumption drops to  $I_{CC1}$ .

Deep power-down mode enbles users to place the device in the lowest power consumption mode,  $I_{CC2}$ . The ENTER DEEP POWER-DOWN command is used to put the device in deep power-down mode, and the RELEASE FROM DEEP POWER-DOWN command is used to bring the device out of deep power-down mode. Command details are in the Command Set table and the Deep Power-Down Operations section of this data sheet.



## **Power Loss and Interface Rescue**

	If a power loss occurs during a WRITE NONVOLATILE CONFIGURATION REGISTER command, after the next power-on, the device might begin in an undetermined state (XIP mode or an unnecessary protocol). If this occurs, a power loss recovery sequence must reset the device to a fixed state (extended SPI protocol without XIP) until the next power-up.
	If the controller and memory device get out of synchronization, the controller can fol- low an interface rescue sequence to reset the memory device interface to power-up to the last reset state (as defined by latest nonvolatile configuration register). This resets only the interface, not the entire memory device, and any ongoing operations are not interrupted.
	After each sequence, the issue should be resolved definitively by running the WRITE NONVOLATILE CONFIGURATION REGISTER command again.
	<b>Note:</b> The two steps in each sequence must be in the correct order, and <sup>t</sup> SHSL2 must be at least 50ns for the duration of each sequence.
	The first step for both the power loss recovery and interface rescue sequences is descri- bed under "Recovery." The second step in the power loss recovery sequence is under "Power Loss Recovery" and the second step in the interface rescue sequence is under "Interface Rescue."
Recovery	
	Step one of both the power loss recovery and interface rescue sequences is DQ0 (PAD DATA) and DQ3 (PAD HOLD) equal to 1 for the situations listed here:
	<ul> <li>7 clock cycles within S# LOW (S# becomes HIGH before 8th clock cycle)</li> <li>+ 9 clock cycles within S# LOW (S# becomes HIGH before 10th clock cycle)</li> <li>+ 13 clock cycles within S# LOW (S# becomes HIGH before 14th clock cycle)</li> <li>+ 17 clock cycles within S# LOW (S# becomes HIGH before 18th clock cycle)</li> <li>+ 25 clock cycles within S# LOW (S# becomes HIGH before 26th clock cycle)</li> <li>+ 33 clock cycles within S# LOW (S# becomes HIGH before 34th clock cycle)</li> </ul>
Power Loss Recove	

### **Power Loss Recovery**

For power loss recovery, the second part of the sequence is exiting from dual or quad SPI protocol by using the following FFh sequence: DQ0 and DQ3 equal to 1 for 8 clock cycles within S# LOW; S# becomes HIGH before 9th clock cycle. After this two-part sequence the extended SPI protocol is active.

### **Interface Rescue**

For interface rescue, the second part of the sequence is for exiting from dual or quad SPI protocol by using the following FFh sequence: DQ0 and DQ3 equal to 1 for 16 clock cycles within S# LOW; S# becomes HIGH before 17th clock cycle. For DTR protocol, 1 should be driven on both edges of clock for 16 cycles with S# LOW. After this two-part sequence, the extended SPI protocol is active.



# **Initial Delivery Status**

The device is delivered as follows:

- Memory array erased: all bits are set to 1 (each byte contains FFh)
- Status register contains 00h (all status register bits are 0)
- Nonvolatile configuration register (NVCR) bits all erased (FFFFh)



## **Absolute Ratings and Operating Conditions**

Stresses greater than those listed may cause permanent damage to the device. This is a stress rating only. Exposure to absolute maximum rating for extended periods may adversely affect reliability. Stressing the device beyond the absolute maximum ratings may cause permanent damage.

#### **Table 44: Absolute Ratings**

Symbol	Parameter	Min	Мах	Units	Notes
T <sub>STG</sub>	Storage temperature	-65	150	°C	
T <sub>LEAD</sub>	Lead temperature during soldering	-	See note 1	°C	
V <sub>cc</sub>	Supply voltage	-0.6	2.4	V	2
V <sub>IO</sub>	Input/output voltage with respect to ground	-0.6	V <sub>CC</sub> + 0.6	V	2
V <sub>ESD</sub>	Electrostatic discharge voltage (human body model)	-2000	2000	V	2, 3

- Notes: 1. Compliant with JEDEC Standard J-STD-020C (for small-body, Sn-Pb or Pb assembly), RoHS, and the European directive on Restrictions on Hazardous Substances (RoHS) 2002/95/EU.
  - 2. All specified voltages are with respect to V<sub>SS</sub>. During infrequent, nonperiodic transitions, the voltage potential between V<sub>SS</sub> and the V<sub>CC</sub> may undershoot to –2.0V for periods less than 20ns, or overshoot to V<sub>CC,max</sub> + 2.0V for periods less than 20ns.
  - 3. JEDEC Standard JESD22-A114A (C1 = 100pF, R1 = 1500Ω, R2 = 500Ω).

#### **Table 45: Operating Conditions**

Symbol	Parameter	Min	Мах	Units
V <sub>cc</sub>	Supply voltage	1.7	2.0	V
T <sub>A</sub>	Ambient operating temperature (IT range)	-40	85	°C
T <sub>A</sub>	Ambient operating temperature (AT range)	-40	105	°C
T <sub>A</sub>	Ambient operating temperature (UT range)	-40	125	°C

### Table 46: Input/Output Capacitance

Note 1 applies to entire table

Symbol	Description	Test Condition	Min	Мах	Units
C <sub>IN/OUT</sub>	Input/output capacitance (DQ0/DQ1/DQ2/DQ3)	V <sub>OUT</sub> = 0V	-	10	pF
C <sub>IN</sub>	Input capacitance (other pins)	$V_{IN} = 0V$	-	6	pF
C <sub>IN/S#</sub>	Input capacitance (other pins)	$V_{IN} = 0V$	-	10	pF

Note: 1. These parameters are sampled only, not 100% tested.  $T_A = 25^{\circ}C$  at 54 MHz.

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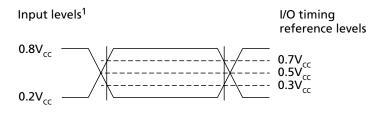
### **Table 47: AC Timing Input/Output Conditions**

Symbol	Description	Min	Мах	Units	Notes
CL	C <sub>L</sub> Load capacitance		30	pF	1
-	Input rise and fall times – 1.5		1.5	ns	
	Input pulse voltages 0.2V <sub>CC</sub> to 0.8V <sub>CC</sub>		o 0.8V <sub>CC</sub>	V	2
	Input timing reference voltages	0.3V <sub>CC</sub> to 0.7V <sub>CC</sub> V			
	Output timing reference voltages	Vc	<sub>c</sub> /2	V	

Notes: 1. Output buffers are configurable by user.

2. For quad/dual operations: 0V to V<sub>CC</sub>.

### Figure 48: AC Timing Input/Output Reference Levels



Note: 1.  $0.8V_{CC} = V_{CC}$  for dual/quad operations;  $0.2V_{CC} = 0V$  for dual/quad operations.



# **DC Characteristics and Operating Conditions**

### **Table 48: DC Current Characteristics and Operating Conditions**

Notes apply to entire table.

Parameter	Symbol	Test Conditions	Тур	Мах	Unit
Input leakage current	ILI		_	±2	μΑ
Output leakage current	I <sub>LO</sub>		_	±2	μΑ
Standby current (IT range)	I <sub>CC1</sub>	$S\# = V_{CC}, V_{IN} = V_{SS} \text{ or } V_{CC}$	20	100	μA
Standby current (AT range)		S# = $V_{CC}$ , $V_{IN}$ = $V_{SS}$ or $V_{CC}$	20	200	μA
Standby current (UT range)		S# = $V_{CC}$ , $V_{IN}$ = $V_{SS}$ or $V_{CC}$	20	300	μA
Deep power-down current (IT range)	I <sub>CC2</sub>	S# = $V_{CC}$ , $V_{IN}$ = $V_{SS}$ or $V_{CC}$	2	50	μA
Deep power-down current (AT range)		S# = $V_{CC}$ , $V_{IN}$ = $V_{SS}$ or $V_{CC}$	5	100	μA
Deep power-down current (UT range)		$S\# = V_{CC}, V_{IN} = V_{SS} \text{ or } V_{CC}$	5	150	μΑ
Operating current (fast-read extended I/O)	I <sub>CC3</sub>	$C = 0.1V_{CC}/0.9V_{CC} \text{ at } 166 \text{ MHz},$ $DQ1 = \text{open}$	-	20	mA
		$C = 0.1V_{CC}/0.9V_{CC} \text{ at 54 MHz},$ $DQ1 = \text{open}$	-	8	mA
Operating current (fast-read dual I/O)		C = $0.1V_{CC}/0.9V_{CC}$ at 166 MHz, DQ = open	-	25	mA
Operating current (fast-read quad I/O), IT and AT range		$C = 0.1V_{CC}/0.9V_{CC} \text{ at } 166 \text{ MHz STR}$ or 80 MHz DTR, DQ = open	-	28	mA
		$C = 0.1V_{CC}/0.9V_{CC} \text{ at } 90 \text{ MHz DTR},$ $DQ = \text{open}$	-	31	mA
Operating current (fast-read quad I/O), UT range		$C = 0.1V_{CC}/0.9V_{CC}$ at 133 MHz STR or 80 MHz DTR, DQ = open	-	28	mA
Operating current (PROGRAM operations)	I <sub>CC4</sub>	S# = V <sub>CC</sub>	_	35	mA
Operating current (WRITE operations)	I <sub>CC5</sub>	S# = V <sub>CC</sub>	_	35	mA
Operating current (erase)	I <sub>CC6</sub>	S# = V <sub>CC</sub>	_	35	mA

Notes: 1. All currents are RMS unless noted. Typical values at typical V<sub>CC</sub> (3.0/1.8V); V<sub>IO</sub> = 0V/V<sub>CC</sub>;  $T_C = +25^{\circ}C$ .

- 2. Standby current is the average current measured over any time interval 5µs after S deassertion (and any internal operations are complete).
- 3. Deep power-down current is the average current measured 5ms over any 5ms time interval, 100µs after the ENTER DEEP POWER-DOWN operation (and any internal operations are complete).
- 4. All read currents are the average current measured over any 1KB continuous read. No load, checker-board pattern.
- 5. All program currents are the average current measured over any 256-byte typical data program.



### **Table 49: DC Voltage Characteristics and Operating Conditions**

Parameter	Symbol	Conditions	Min	Мах	Unit
Input low voltage	V <sub>IL</sub>		-0.5	0.3V <sub>CC</sub>	V
Input high voltage	V <sub>IH</sub>		0.7V <sub>CC</sub>	V <sub>CC</sub> + 0.4	V
Output low voltage	V <sub>OL</sub>	I <sub>OL</sub> = 1.6mA	_	0.4	V
Output high voltage	V <sub>OH</sub>	I <sub>OH</sub> = −100μA	V <sub>CC</sub> - 0.2	-	V

Note: 1.  $V_{IL}$  can undershoot to -1.0V for periods <2ns and  $V_{IH}$  may overshoot to  $V_{CC,max}$  + 1.0V for periods less than 2ns.



# **AC Characteristics and Operating Conditions**

### Table 50: Max frequency supported

Parameter	Symbol	Parts	Single IO STR	Single IO DTR	Dual IO STR	Dual IO DTR	Quad IO STR	Quad IO DTR
Clock frequency for all commands other than		IT & AT	166	90	166	90	166	90
READ (Extended-SPI, DIO- SPI, and QIO-SPI proto- col) [Mhz]	fC	UT	166	90	166	90	133	80
Clock frequency for READ command (03h) [Mhz]	fR	IT, AT & UT	54	27				

### **Table 51: AC Characteristics and Operating Conditions**

Parameter	Symbol	Data Transfer Rate	Min	Тур	Max	Unit	Notes
Clock HIGH time	<sup>t</sup> CH	STR	2.7	-	_	ns	2,3
		DTR	5.0	-	-	-	
Clock LOW time	<sup>t</sup> CL	STR	2.7	-	_	ns	2,4
		DTR	5.0	-	-	_	
Clock rise time (peak-to-peak)	<sup>t</sup> CLCH	STR/DTR	0.1	-	-	V/ns	5, 6
Clock fall time (peak-to-peak)	<sup>t</sup> CHCL	STR/DTR	0.1	-	-	V/ns	5, 6
S# active setup time (relative to clock)	<sup>t</sup> SLCH	STR/DTR	2.7	-	-	ns	
S# not active hold time (relative to clock)	<sup>t</sup> CHSL	STR/DTR	2.7	-	-	ns	
Data in setup time	<sup>t</sup> DVCH	STR/DTR	1.75	-	-	ns	
	<sup>t</sup> DVCL	DTR only	1.75	-	-	ns	
Data in hold time	<sup>t</sup> CHDX	STR	2	-	-	ns	
		DTR	2.3	-	-	ns	
	<sup>t</sup> CLDX	DTR only	2.3	-	-	ns	
S# active hold time (relative to clock)	<sup>t</sup> CHSH	STR	2.7	-	-	ns	
		DTR	5.0	-	-		
S# active hold time (relative to clock LOW) Only for writes in DTR	<sup>t</sup> CLSH	DTR only	3.375	-	-	ns	
S# not active setup time (relative to clock)	<sup>t</sup> SHCH	STR	2.7	-	-	ns	
		DTR	5.0	-	-	ns	
S# deselect time after a READ command	<sup>t</sup> SHSL1	STR/DTR	6	-	-	ns	
S# deselect time after a nonREAD com- mand	<sup>t</sup> SHSL2	STR/DTR	30	-	-	ns	7
Output disable time	<sup>t</sup> SHQZ	STR/DTR	-	-	6	ns	5



### 512Mb, 1.8V Multiple I/O Serial Flash Memory AC Characteristics and Operating Conditions

### Table 51: AC Characteristics and Operating Conditions (Continued)

Parameter	Symbol	Data Transfer Rate	Min	Тур	Max	Unit	Notes
Clock LOW to output valid under 30pF	tCLQV	STR/DTR	-	-	6	ns	notes
Clock LOW to output valid under 10pF		STR/DTR	_		5	ns	
Clock HIGH to output valid under 30pF	tCHQV	DTR only	_	_	6	ns	
Clock HIGH to output valid under 10pF		DTR only	_	_	5	ns	
Output hold time	<sup>t</sup> CLQX	STR/DTR	1	_	_	ns	
Output hold time	tCHQX	DTR only	1	_	_	ns	
HOLD setup time (relative to clock)	tHLCH	STR/DTR	2.7	_	_	ns	
HOLD hold time (relative to clock)	tCHHH	STR/DTR	2.7	_	_	ns	
HOLD setup time (relative to clock)	tHHCH	STR/DTR	2.7	_	_	ns	
HOLD hold time (relative to clock)	tCHHL	STR/DTR	2.7		_	ns	
HOLD to output Low-Z	tHHQX	STR/DTR	_	_	5	ns	5
HOLD to output High-Z	tHLQZ	STR/DTR	_	_	5	ns	5
CRC check time: main block	tCRC	STR/DTR	_	1.3	-	ms	
CRC check time: full chip (512Mb)	<sup>t</sup> CRC	STR/DTR	_	2	-	s	
Write protect setup time	tWHSL	STR/DTR	20	_	_	ns	8
Write protect hold time	<sup>t</sup> SHWL	STR/DTR	100	_	_	ns	8
S# HIGH to deep power-down	<sup>t</sup> DP	STR/DTR	3	_	_	μs	
S# HIGH to standby mode (DPD exit time)	tRDP	STR/DTR	30	_	_	μs	
WRITE STATUS REGISTER cycle time	tW	STR/DTR	-	1.3	8	ms	
WRITE NONVOLATILE CONFIGURATION REGISTER cycle time	tWNVCR	STR/DTR	-	0.2	1	S	
Nonvolatile sector lock time	tPPBP	STR/DTR	-	0.1	2.8	ms	
Program ASP register	<sup>t</sup> ASPP	STR/DTR	-	0.1	0.5	ms	
Program password	<sup>t</sup> PASSP	STR/DTR	-	0.2	0.8	ms	
Erase nonvolatile sector lock array	<sup>t</sup> PPBE	STR/DTR	-	0.2	1	s	
Page program time (256 bytes)	tPP	STR/DTR	-	120	1800	μs	9
Page program time (n bytes)	_		-	18 + 2.5 × int(n/6)	1800	μs	10
PROGRAM OTP cycle time (64 bytes)	<sup>t</sup> POTP	STR/DTR	-	0.12	0.8	ms	
Sector erase time	<sup>t</sup> SE	STR/DTR	-	0.15	1	s	
4KB subsector erase time	tSSE	STR/DTR	-	0.05	0.4	s	
32KB subsector erase time	tSSE	STR/DTR	-	0.1	1	s	
512Mb bulk erase time	<sup>t</sup> BE	STR/DTR	-	153	460	s	

Notes: 1. Typical values given for  $T_A = 25$  °C.

- 2.  ${}^{t}CH + {}^{t}CL$  must add up to  $1/{}^{f}C$ .
- 3. Only for AT parts in Quad I/O:  $t_{CH}$  in STR = 3.375ns [min];  $t_{CH}$  in DTR = 5.62ns [min]
- 4. Only for AT parts in Quad I/O:  $t_{CL}$  in STR = 3.375ns [min];  $t_{CL}$  in DTR = 5.62ns [min]



- 5. Value guaranteed by characterization; not 100% tested.
- 6. Expressed as a slew-rate.
- 7. nonREAD commands are WRITE, PROGRAM and ERASE.
- 8. Only applicable as a constraint for a WRITE STATUS REGISTER command when STATUS REGISTER WRITE is set to 1.
- 9. Typical value is applied for pattern: 50% "0" and 50% "1".
- 10. int(n) correspond to the integer part of n, For example int (12/8)=1, int (32/8)=4 int(15.3)=15.



# **AC Reset Specifications**

### **Table 52: AC RESET Conditions**

Note 1 applies to entire table

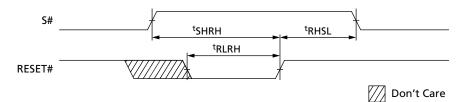
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Reset pulse width	<sup>t</sup> RLRH <sup>2</sup>		50	-	-	ns
Reset recovery	<sup>t</sup> RHSL	Device deselected (S# HIGH) and is in XIP mode	40	-	_	ns
time		Device deselected (S# HIGH) and is in standby mode	40	-	_	ns
		Commands are being decoded, any READ operations are in progress or any WRITE operation to volatile registers are in progress	40	-	-	ns
		Any device array PROGRAM/ERASE/SUSPEND/RESUME, PROGRAM OTP, NONVOLATILE SECTOR LOCK, and ERASE NONVOLATILE SECTOR LOCK ARRAY operations are in progress	30	-	-	μs
		While a WRITE STATUS REGISTER operation is in progress	-	<sup>t</sup> W	_	ms
		While a WRITE NONVOLATILE CONFIGURATION REGIS- TER operation is in progress	-	<sup>t</sup> WNVCR	-	ms
		On completion or suspension of a SUBSECTOR ERASE op- eration	-	<sup>t</sup> SSE	-	S
		Device in deep power-down mode	-	<sup>t</sup> RDP	_	ms
		While ADVANCED SECTOR PROTECTION PROGRAM oper- ation is in progress	-	<sup>t</sup> ASPP	-	ms
		While PASSWORD PROTECTION PROGRAM operation is in progress	-	<sup>t</sup> PASSP	-	ms
Software reset	<sup>t</sup> SHSL3	Device deselected (S# HIGH) and is in standby mode	40	-	_	ns
recovery time		Any Flash array PROGRAM/ERASE/SUSPEND/RESUME, PROGRAM OTP, NONVOLATILE SECTOR LOCK, and ERASE NONVOLATILE SECTOR LOCK ARRAY operations are in progress	30	_	-	μs
		While WRITE STATUS REGISTER operation is in progress	-	tW	_	ms
		While a WRITE NONVOLATILE CONFIGURATION REGIS- TER operation is in progress	_	tWNVCR	-	ms
		On completion or suspension of a SUBSECTOR ERASE op- eration	_	<sup>t</sup> SSE	-	S
		Device in deep power-down mode	_	<sup>t</sup> RDP	_	ms
		While ADVANCED SECTOR PROTECTION PROGRAM oper- ation is in progress	_	<sup>t</sup> ASPP	_	ms
		While PASSWORD PROTECTION PROGRAM operation is in progress	-	<sup>t</sup> PASSP	-	ms

Notes: 1. Values are guaranteed by characterization; not 100% tested.

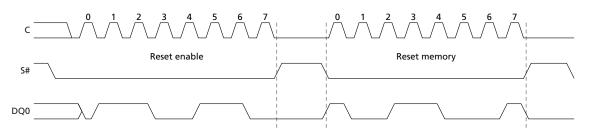
2. The device reset is possible but not guaranteed if  ${}^{t}RLRH < 50$ ns.



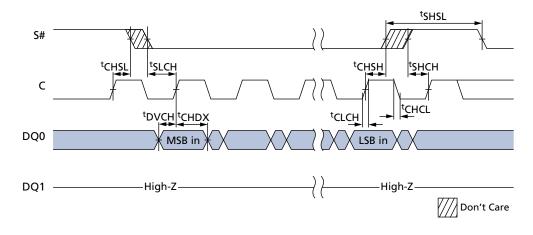
#### Figure 49: Reset AC Timing During PROGRAM and ERASE Cycle



### Figure 50: Reset Enable and Reset Memory Timing

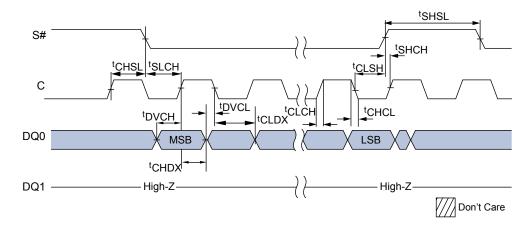


### Figure 51: Serial Input Timing STR

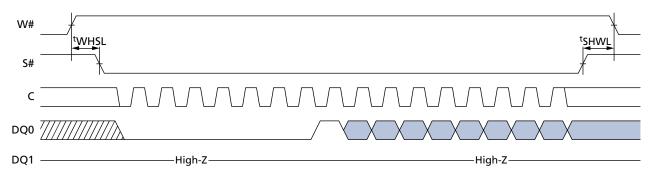




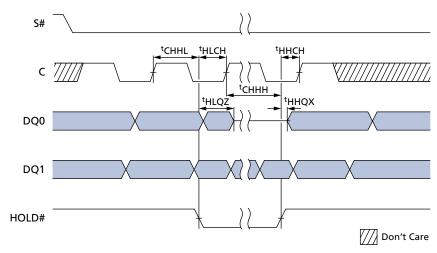
### Figure 52: Serial Input Timing DTR



### Figure 53: Write Protect Setup and Hold During WRITE STATUS REGISTER Operation (SRWD = 1)



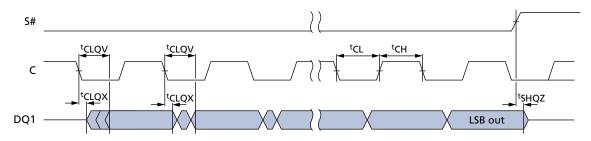




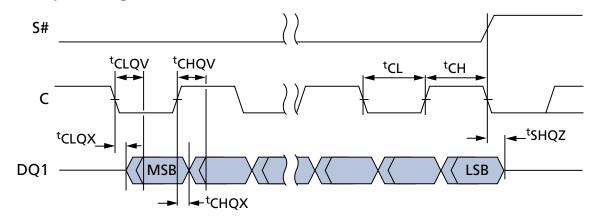
### Figure 54: Hold Timing



### Figure 55: Output Timing for STR



### Figure 56: Output Timing for DTR





## **Program/Erase Specifications**

#### Table 53: Program/Erase Specifications

Parameter	Condition	Тур	Max	Units	Notes
Erase to suspend	Sector erase or erase resume to erase suspend	150	-	μs	1
Program to suspend	Program resume to program suspend	5	-	μs	1
Subsector erase to suspend	Subsector erase or subsector erase resume to erase suspend	50	-	μs	1
Suspend latency	Program	7	25	μs	2
Suspend latency	Subsector erase	15	30	μs	2
Suspend latency	Erase	15	30	μs	3

Notes: 1. Timing is not internally controlled.

2. Any READ command accepted.

3. Any command except the following are accepted: SECTOR, SUBSECTOR, or BULK ERASE; WRITE STATUS REGISTER; WRITE NONVOLATILE CONFIGURATION REGISTER; and PRO-GRAM OTP.



# **Revision History**

Rev. F - 1/18	
	<ul> <li>Added Important Notes and Warnings section for further clarification aligning to in- dustry standards</li> </ul>
	<ul> <li>Added supported clock frequencies tables for UT temperature range</li> </ul>
	Added DEEP POWER-DOWN Operations
	<ul> <li>Added Active Power, Standby Power, and Deep Power-Down modes</li> </ul>
	<ul> <li>Added AC/DC characteristic for UT temperature range</li> </ul>
	Added figure for Serial Input Timing DTR
Rev. E – 06/17	
	• Added UT device (operating temperature range: from –40°C to +125°C)
	• Updated Data in hold time in AC Characteristics and Operating Conditions table
	Updated Page program time in AC Characteristics and Operating Conditions table
Rev. D – 06/16	
	<ul> <li>Updated Clock Frequencies – DTR (in MHz) table</li> </ul>
	• Updated maximum DTR frequency to 90 MHz
	Updated <sup>t</sup> CLDX specification in AC Characteristics and Operating Conditions
Rev. C – 06/16	
	• Added general purpose read register notes to Command Definitions table
Rev. B – 03/16	
	Changed status from preliminary to production
Rev. A - 06/15	
	Initial release

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This data sheet contains minimum and maximum limits specified over the power supply and temperature range set forth herein. Although considered final, these specifications are subject to change, as further product development and data characterization sometimes occur.